

NO.: RZA2007-0912FCC

# TEST REPORT

<b>Test name</b>	Electromagnetic Field (Specific Absorption Rate)
<b>Product</b>	EDGE USB STICK
<b>Model</b>	EG162
<b>FCC ID</b>	QISEG162
<b>Client</b>	HUAWEI Technologies Co., Ltd.

**TA Technology (Shanghai) Co., Ltd.**



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**Address:** Room4,No.399,Cailun Rd,Zhangjiang Hi-Tech Park, Pudong Shanghai,China

**Post code:** 201203

**Telephone:** +86-021-50791141/2/3

**Fax:** +86-021-50791147

**Website:** <http://www.ta-shanghai.com>

**E-mail:** [service@ta-shanghai.com](mailto:service@ta-shanghai.com)

# TA Technology (Shanghai) Co., Ltd. Test Report

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## GENERAL SUMMARY

<b>Product</b>	EDGE USB STICK	<b>Model</b>	EG162
<b>Client</b>	HUAWEI Technologies Co., Ltd.	<b>Type of test</b>	Entrusted
<b>Manufacturer</b>	HUAWEI Technologies Co., Ltd.	<b>Arrival Date of sample</b>	Sept.20 <sup>th</sup> , 2007
<b>Place of sampling</b>	(Blank)	<b>Carrier of the samples</b>	XieYan
<b>Quantity of the samples</b>	One	<b>Date of product</b>	(Blank)
<b>Base of the samples</b>	(Blank)	<b>Items of test</b>	SAR
<b>Series number</b>	EM01AA1791300041		
<b>Standard(s)</b>	<p><b>EN 50360–2001:</b> Product standard for the measurement of Specific Absorption Rate related to human exposure to electromagnetic fields from mobile phones.</p> <p><b>EN 50361–2001:</b> Basic standard for the measurement of Specific Absorption Rate related to human exposure to electromagnetic fields from mobile phones.</p> <p><b>ANSI C95.1–1999:</b> IEEE Standard for Safety Levels with Respect to Human Exposure to Radio Frequency Electromagnetic Fields, 3 kHz to 300 GHz</p> <p><b>IEEE 1528–2003:</b> Recommended Practice for Determining the Peak Spatial-Average Specific Absorption Rate (SAR) in the Human Body Due to Wireless Communications Devices: Experimental Techniques.</p> <p><b>OET Bulletin 65 (Edition 97-01) and Supplement C (Edition 01-01):</b> Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits.</p> <p><b>IEC 62209-2 (Draft):</b> Human exposure to radio frequency fields from hand-held and body-mounted wireless communication devices – Human models, instrumentation, and procedures –Part 2: Procedure to determine the Specific Absorption Rate (SAR)in the head and body for 30MHz to 6GHz Handheld and Body-Mounted Devices used in close proximity to the body.</p> <p><b>Vodafone SAR_Data_cards_V1.1:</b> Global Test Specification for Terminals for Performance Measurements –Performance TST- Specific Absorption Rate (SAR) for Data Cards and External Antennas.</p>		
<b>Conclusion</b>	<p>Localized Specific Absorption Rate (SAR) of this portable wireless equipment has been measured in all cases requested by the relevant standards cited in Clause 5.2 of this test report. Maximum localized SAR is below exposure limits specified in the relevant standards cited in Clause 5.1 of this test report.</p> <p>General Judgment: <b>Pass</b></p> <p style="text-align: right;">(Stamp) <b>Date of issue: Sep. 29<sup>th</sup>, 2007</b></p>		
<b>Comment</b>	The test result only responds to the measured sample.		

Approved by

(Zhengchenguang)

Revised by

(Yangweizhong)

Performed by

(Lingminbao)

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## 1 COMPETENCE AND WARRANTIES

**TA Technology (Shanghai) Co., Ltd.** is a test laboratory competent to carry out the tests described in this test report.

**TA Technology (Shanghai) Co., Ltd.** guarantees the reliability of the data presented in this test report, which is the results of measurements and tests performed for the items under test on the date and under the conditions stated in this test report and is based on the knowledge and technical facilities available at TA Technology (Shanghai) Co., Ltd. at the time of execution of the test.

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## 3 DESCRIPTION OF EUT

### 3.1 Addressing Information Related to EUT

**Table 1: Applicant (The Client)**

Name or Company	HUAWEI Technologies Co., Ltd.
Address/Post	Bantian, Longgang District
City	Shenzhen
Postal Code	518129
Country	P.R. China
Telephone	0755-28780808
Fax	0755-28780808

**Table 2: Manufacturer**

Name or Company	HUAWEI Technologies Co., Ltd.
Address/Post	Bantian, Longgang District
City	Shenzhen
Postal Code	518129
Country	P.R. China
Telephone	0755-28780808
Fax	0755-28780808

### 3.2 Constituents of EUT

**Table 3: Constituents of Samples**

Description	Model	Serial Number	Manufacturer
EDGE USB STICK	EG162	EM01AA1791300041	HUAWEI Technologies Co., Ltd.



**Picture 1: Constituents of the sample**

### 3.3 General Description

Equipment Under Test (EUT) is a EDGE USB STICK with internal antenna. During SAR test of the EUT, it was connected to three different portable computers. SAR is tested for the EUT respectively for GSM 850 and GSM1900. The EUT have GPRS(class 10) and EGPRS (class 12) function. Since the EUT only has the data transfer function, but does not have the voice transfer function, the tests in the band of GSM 850 and GSM 1900 are only performed in the mode of GPRS and EGPRS. The measurements were performed in combination with three different host products (BENQ Joy book S72, IBM X41 and BenQ R55V). BENQ Joy book S72 and IBM X41 laptop have horizontal USB slots, BenQ R55V laptop has vertical USB slot.

The sample under test was selected by the Client.

Components list please refer to documents of the manufacturer.

## 4 OPERATIONAL CONDITIONS DURING TEST

### 4.1 Schematic Test Configuration

For the SAR body tests for GSM 850 and GSM1900, a communication link is set up with a System Simulator (SS) by air link. The EUT is commanded to operate at maximum transmitting power. Since the EUT only has the data transfer function, but does not have the voice transfer function. The tests in the band of GSM 850 and GSM 1900 are performed in the mode of GPRS and EGPRS. And since the GPRS class is 10 for this EUT, it has at most 2 timeslots in uplink. According to specification 3GPP TS 51.010, the maximum power of the GSM can do the power reduction for the multi-slot. The allowed power reduction in the multi-slot configuration is as following:

Number of timeslots in uplink assignment	Permissible reduction of maximum output power (dB)
1	0
2	0 to 3.0

For this EUT, the tests for GSM 850 GPRS and GSM 1900 GPRS band will be performed under the following 2 setups at one same test position:

- 1) using 1 timeslot in uplink with the power of 33 dBm for GSM 850 and 30 dBm for GSM 1900
- 2) using 2 timeslots in uplink with the power reduced 2dB

After drawn the worst case, the tests will be continued to perform with the same EUT setup for the whole tests for GSM 850 GPRS and GSM 1900 GPRS.

And according to the "2 dB rule" specified in the OET Bulletin 65 (Edition 97-01) and Supplement C(Edition 01-01), "**If the SAR measured at the middle channel for each test configuration (left, right, Cheek/Touch, Tile/Ear, extended and retracted) is at least 2.0 dB lower than the SAR limit, testing at the high and low channels is optional for such test configuration(s)**".

Then The Absolute Radio Frequency Channel Number (ARFCN) is firstly allocated to 190 and 661 respectively in the case of GSM 850 and GSM 1900 then to low and high if necessary

the EUT is tested at the following 6 test positions:

- Test Position 1: The EUT is connected to the portable computer with horizontal USB slot. The back side of the EUT is towards the bottom of the flat phantom. (Picture 2-a)
- Test Position 2: The EUT is connected to the portable computer with horizontal USB slot. The front side of the EUT is towards the bottom of the flat phantom. (Picture 2-b)
- Test Position 3: The EUT is connected to the portable computer with vertical / horizontal USB slot. The top side of the EUT is towards the bottom of the flat phantom. (Picture 2-c)
- Test Position 4: The EUT is connected to the portable computer with vertical USB slot. The front side of the EUT is towards the bottom of the flat phantom. (Picture 2-d)
- Test Position 5: The EUT is connected to the portable computer with vertical USB slot. The left side of the EUT is towards the bottom of the flat phantom. (Picture 2-e)
- Test Position 6: The EUT is connected to the portable computer with vertical USB slot. The right side of the EUT is towards the bottom of the flat phantom. (Picture 2-f)



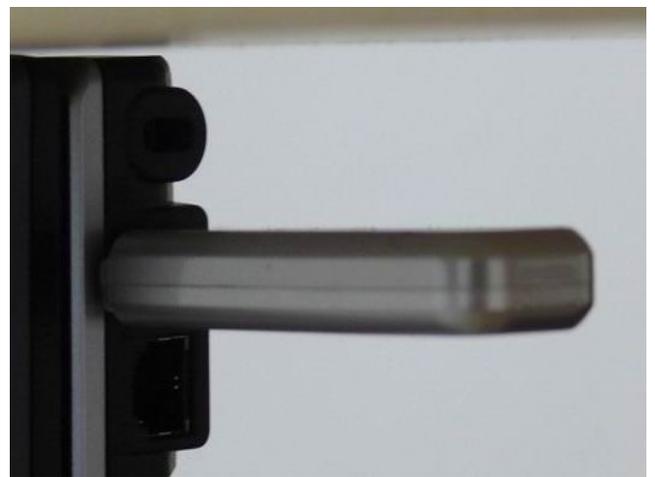
Picture 2-a: Test position 1



Picture 2-b: Test position 2



Picture 2-c: Test position 3



Picture 2-d: Test position 4



Picture 2-e: Test position 5



Picture 2-f: Test position 6

Picture 2: Test positions of EUT

Show the distance that the back side of the EUT with different computer is towards the bottom of the Phantom.



Picture 3-a: EUT with BenQ Joy book S72



Picture 3-b: EUT with IBM X41

**Picture 3: The EUT back side towards the phantom with different computer**

During the test, The BenQ Joy book S72 laptop, IBM X41 laptop and BenQ R55V laptop are used as an assistant to help to setup communication. (See Picture 4)



Picture 4-a: BenQ Joy book S72 Close



Picture 4-b: BenQ Joy book S72 Open



Picture 4-c: IBM X41 Close



Picture 4-d: IBM X41 Open



Picture 4-e: BenQ R55V Close



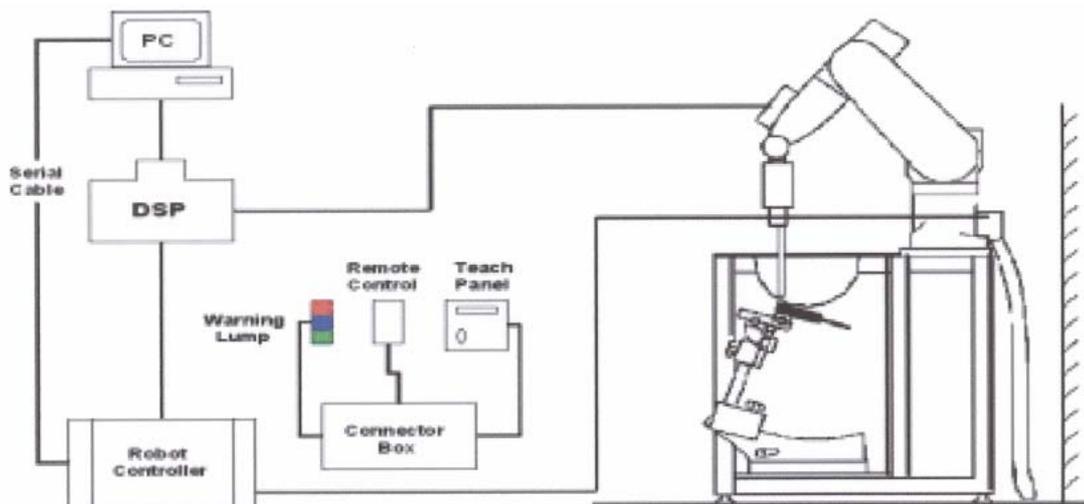
Picture 4-f: BenQ R55V Open

**Picture 4: Computer as a test assistant**

## 4.2 SAR Measurement Set-up

These measurements were performed with the automated near-field scanning system DASY4 from Schmid & Partner Engineering AG (SPEAG). The system is based on a high precision robot (working range greater than 0.9m) which positions the probes with a positional repeatability of better than  $\pm 0.02\text{mm}$ . Special E- and H-field probes have been developed for measurements close to material discontinuity, the sensors of which are directly loaded with a Schottky diode and connected via highly resistive lines (length =300mm) to the data acquisition unit.

A cell controller system contains the power supply, robot controller, teaches pendant (Joystick) and remote control, is used to drive the robot motors. The PC consists of the Micron Pentium III 800 MHz computer with Windows 2000 system and SAR Measurement Software DASY4, A/D interface card, monitor, mouse, and keyboard. The Stäubli Robot is connected to the cell controller to allow software manipulation of the robot. A data acquisition electronic (DAE) circuit performs the signal amplification, signal multiplexing, AD-conversion, offset measurements, mechanical surface detection, collision detection, etc. is connected to the Electro-optical coupler (EOC). The EOC performs the conversion from the optical into digital electric signal of the DAE and transfers data to the PC plug-in card.



**Figure1. SAR Lab Test Measurement Set-up**

The DAE3 consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the PC-card is accomplished through an optical downlink for data and status information and an optical uplink for commands and clock lines. The mechanical probe mounting device includes two different sensor systems for frontal and sidewise probe contacts. They are also used for mechanical surface detection and probe collision detection. The robot uses its own controller with a built in VME-bus computer.

### 4.3 Dasy4 E-field Probe System

The SAR measurements were conducted with the dosimetric probe ET3DV6 (manufactured by SPEAG), designed in the classical triangular configuration and optimized for dosimetric evaluation. The probe has been calibrated according to the standard procedure with an accuracy of better than  $\pm 10\%$ . The spherical isotropy was evaluated and found to be better than  $\pm 0.25\text{dB}$ .

#### ET3DV6 Probe Specification

Construction	Symmetrical design with triangular core Built-in optical fiber for surface detection System(ET3DV6 only) Built-in shielding against static charges PEEK enclosure material(resistant to organic solvents, e.g., glycol)
Calibration	In air from 10 MHz to 2.5 GHz In brain and muscle simulating tissue at frequencies of 450MHz, 900MHz and 1.8GHz (accuracy $\pm 8\%$ ) Calibration for other liquids and frequencies upon request
Frequency	10 MHz to > 6 GHz; Linearity: $\pm 0.2\text{ dB}$ (30 MHz to 3 GHz)
Directivity	$\pm 0.2\text{ dB}$ in brain tissue (rotation around probe axis) $\pm 0.4\text{ dB}$ in brain tissue (rotation normal probe axis)
Dynamic Range	5 $\mu\text{W/g}$ to > 100mW/g; Linearity: $\pm 0.2\text{ dB}$
Surface Detection	$\pm 0.2\text{ mm}$ repeatability in air and clear liquids over diffuse reflecting surface(ET3DV6 only)
Dimensions	Overall length: 330mm Tip length: 16mm Body diameter: 12mm Tip diameter: 6.8mm Distance from probe tip to dipole centers: 2.7mm
Application	General dosimetry up to 3GHz Compliance tests of mobile phones Fast automatic scanning in arbitrary phantoms

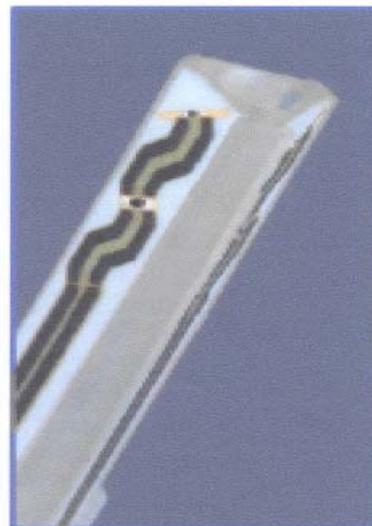


Figure2. ET3DV6 E-field Probe



Figure3. ET3DV6 E-field probe

#### 4.4 E-field Probe Calibration

Each probe is calibrated according to a dosimetric assessment procedure with accuracy better than  $\pm 10\%$ . The spherical isotropy was evaluated and found to be better than  $\pm 0.25\text{dB}$ . The sensitivity parameters (NormX, NormY, NormZ), the diode compression parameter (DCP) and the conversion factor (ConvF) of the probe are tested.

The free space E-field from amplified probe outputs is determined in a test chamber. This is performed in a TEM cell for frequencies below 1 GHz, and in a wave guide above 1 GHz for free space. For the free space calibration, the probe is placed in the volumetric center of the cavity and at the proper orientation with the field. The probe is then rotated 360 degrees.

E-field temperature correlation calibration is performed in a flat phantom filled with the appropriate simulated brain tissue. The measured free space E-field in the medium correlates to temperature rise in a dielectric medium. For temperature correlation calibration a RF transparent thermistor-based temperature probe is used in conjunction with the E-field probe.

$$\text{SAR} = C \frac{\Delta T}{\Delta t}$$

Where:  $\Delta t$  = Exposure time (30 seconds),

$C$  = Heat capacity of tissue (brain or muscle),

$\Delta T$  = Temperature increase due to RF exposure.

Or

$$\text{SAR} = \frac{|E|^2 \sigma}{\rho}$$

Where:

$\sigma$  = Simulated tissue conductivity,

$\rho$  = Tissue density (kg/m<sup>3</sup>).

#### 4.5 Other Test Equipment

##### 4.5.1 Device Holder for Transmitters

In combination with the Generic Twin Phantom V3.0, the Mounting Device (POM) enables the rotation of the mounted transmitter in spherical coordinates whereby the rotation points is the ear opening. The devices can be easily, accurately, and repeatedly positioned according to the FCC and CENELEC specifications. The device holder can be locked at different phantom locations (left head, right head, flat phantom).



**Figure4. Device Holder**

##### 4.5.2 Phantom

The Generic Twin Phantom is constructed of a fiberglass shell integrated in a wooden table. The shape of the shell is based on data from an anatomical study designed to determine the maximum exposure in at least 90% of all users. It enables the dosimetric evaluation of left and right hand phone usage as well as body mounted usage at the flat phantom region. A cover prevents the evaporation of the liquid. Reference markings on the Phantom allow

the complete setup of all predefined phantom positions and measurement grids by manually teaching three points in the robot.

Shell Thickness    2±0.1 mm  
 Filling Volume    Approx. 20 liters  
 Dimensions        810 x 1000 x 500 mm (H x L x W)  
 Available         Special



**Figure5. Generic Twin Phantom**

### 4.6 Equivalent Tissues

The liquid used for the frequency range of 800-2000 MHz consisted of water, sugar, salt, Glycol and Cellulose. The liquid has previously been proven to be suited for worst-case. The Table 4 and Table 5 show the detail solution. It's satisfying the latest tissue dielectric parameters requirements proposed by the IEEE 1528.

**Table 4: Composition of the Body Tissue Equivalent Matter**

MIXTURE%	FREQUENCY 850MHz		
<b>Water</b>	<b>52.5</b>		
<b>Sugar</b>	<b>45</b>		
<b>Salt</b>	<b>1.4</b>		
<b>Preventol</b>	<b>0.1</b>		
<b>Cellulose</b>	<b>1.0</b>		
<b>Dielectric Parameters Target Value</b>	<b>f=850MHz</b>	<b>ε=55.2</b>	<b>σ=0.97</b>

**Table 5: Composition of the Body Tissue Equivalent Matter**

MIXTURE%	FREQUENCY 1900MHz		
<b>Water</b>	<b>69.91</b>		
<b>Glycol</b>	<b>29.96</b>		
<b>Salt</b>	<b>0.13</b>		
<b>Dielectric Parameters Target Value</b>	<b>f=1800MHz</b>	<b>ε=53.3</b>	<b>σ=1.52</b>

### 4.7 System Specifications

#### 4.7.1 Robotic System Specifications

##### Specifications

**Positioner:** Stäubli Unimation Corp. Robot Model: RX90L

**Repeatability:** ±0.02 mm

**No. of Axis:** 6

##### Data Acquisition Electronic (DAE) System

###### Cell Controller

**Processor:** Pentium III

**Clock Speed:** 800 MHz

**Operating System:** Windows 2000

**Data Converter**

**Features:** Signal Amplifier, multiplexer, A/D converter, and control logic

**Software:** DASY4 software

**Connecting Lines:** Optical downlink for data and status info. Optical uplink for commands and clock.

## **5 CHARACTERISTICS OF THE TEST**

### **5.1 Applicable Limit Regulations**

**EN 50360–2001:** Product standard for the measurement of Specific Absorption Rate related to human exposure to electromagnetic fields from mobile phones.

It specifies the maximum exposure limit of **2.0 W/kg** as averaged over any 10 gram of tissue for portable devices being used with in 20 cm of the user in the uncontrolled environment.

**ANSI C95.1–1999:** IEEE Standard for Safety Levels with Respect to Human Exposure to Radio Frequency Electromagnetic Fields, 3 kHz to 300 GHz.

It specifies the maximum exposure limit of **1.6 W/kg** as averaged over any 1 gram of tissue for portable devices being used with in 20 cm of the user in the uncontrolled environment.

### **5.2 Applicable Measurement Standards**

**EN 50361–2001:** Basic standard for the measurement of Specific Absorption Rate related to human exposure to electromagnetic fields from mobile phones.

It specifies the measurement method for demonstration of compliance with the SAR limits for such equipments.

**IEEE 1528–2003:** Recommended Practice for Determining the Peak Spatial-Average Specific Absorption Rate (SAR) in the Human Body Due to Wireless Communications Devices: Experimental Techniques.

**OET Bulletin 65 (Edition 97-01) and Supplement C (Edition 01-01):** Additional Information for Evaluating Compliance of Mobile and Portable Devices with FCC Limits.

**IEC 62209-1:** Human exposure to radio frequency fields from hand-held and body-mounted wireless communication devices – Human models, instrumentation, and procedures –Part 1: Procedure to determine the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300 MHz to 3 GHz)

**Vodafone SAR\_Data\_cards\_V1.1:** Global Test Specification for Terminals for Performance Measurements –Performance TST- Specific Absorption Rate (SAR) for Data Cards and External Antennas.

## 6 LABORATORY ENVIRONMENT

**Table 6: The Ambient Conditions during Test**

Temperature	Min. = 18 °C, Max. = 25 °C
Relative humidity	Min. = 30%, Max. = 70%
Ground system resistance	< 0.5 $\Omega$
Ambient noise is checked and found very low and in compliance with requirement of standards. Reflection of surrounding objects is minimized and in compliance with requirement of standards.	

## 7 CONDUCTED OUTPUT POWER MEASUREMENT

### 7.1 Summary

During the process of testing, the EUT was controlled via Digital Radio Communication tester to ensure the maximum power transmission and proper modulation. This result contains conducted output power and ERP for the EUT. In all cases, the measured peak output power should be greater and within 5% than EMI measurement.

### 7.2 Conducted Power

#### 7.2.1 Measurement Methods

The EUT was set up for the maximum output power. The channel power was measured. The measurements were done at 6 channels both before and after SAR tests for each test band.

#### 7.2.2 Measurement result

**Table 7: Conducted Power Measurement Results**

GSM 850	Conducted Power		
	Channel 128 (824.2MHz)	Channel 190 (836.6MHz)	Channel 251 (848.8MHz)
Before Test (dBm)	32.02	32.05	32.00
After Test (dBm)	32.02	32.04	32.01
GSM 1900	Conducted Power		
	Channel 512 (1850.2MHz)	Channel 661 (1880MHz)	Channel 810 (1909.8MHz)
Before Test (dBm)	29.01	28.99	29.03
After Test (dBm)	29.00	28.98	29.01

#### 7.2.3 Power Drift

To control the output power stability during the SAR test, DASY4 system calculates the power drift by measuring the E-field at the same location at the beginning and at the end of the measurement for each test position. These drift values can be found in Table 10 to Table 20 labeled as: (Power Drift [dB]). This ensures that the power drift during one measurement is within 5%.

## 8 TEST RESULTS

### 8.1 Dielectric Performance

**Table 8: Dielectric Performance of Body Tissue Simulating Liquid**

Measurement is made at temperature 22.5 °C and relative humidity 51%. Liquid temperature during the test: 22.3°C			
/	<b>Frequency</b>	<b>Permittivity <math>\epsilon</math></b>	<b>Conductivity <math>\sigma</math> (S/m)</b>
<b>Target value</b>	850MHz	55.2	0.97
	1900MHz	53.3	1.52
<b>Measurement value (Average of 10 tests)</b>	850MHz	55.0	1.00
	1900MHz	52.86	1.53

### 8.2 System Validation

**Table 9: System Validation**

Measurement is made at temperature 23.2 °C, relative humidity 50%, input power 250 mW. Liquid temperature during the test: 22.3°C					
<b>Liquid parameters</b>		<b>Frequency</b>	<b>Permittivity <math>\epsilon</math></b>	<b>Conductivity <math>\sigma</math> (S/m)</b>	
		835MHz	42.8	0.89	
		1900MHz	39.4	1.42	
<b>Verification results</b>	<b>Frequency</b>	<b>Target value (W/kg)</b>		<b>Measurement value (W/kg)</b>	
		<b>10 g Average</b>	<b>1 g Average</b>	<b>10 g Average</b>	<b>1 g Average</b>
	835MHz	1.60	2.48	1.53	2.34
1900MHz	5.09	9.73	5.12	9.69	

Note: Target Values used are one fourth of those in IEEE Std 1528-2003 (feeding power is normalized to 1 Watt), i.e.250 mW is used as feeding power to the validation dipole (SPEAG using).

### 8.3 Summary of Measurement Results

**Table 10: SAR Values [GSM 850 GPRS ( 2 timeslots in uplink )at Test Position 1 with different model computer, Mid frequency]**

Liquid Temperature: 22.6°C			
Limit of SAR (W/kg)	10 g Average	1 g Average	Power Drift (dB)
	2.0	1.6	
Test Case Of Body	Measurement Result (W/kg)		
	10 g Average	1 g Average	
With BenQ Joy book S72 (See Figure 7)	0.551	0.836	-0.001
With IBM X41 (See Figure 9)	0.786	1.220	0.029

**Table 11: SAR Values [GSM 850 GPRS (2 timeslots in uplink) at Test position 1 with IBM X41, different Channel]**

Liquid Temperature: 22.3°C			
Limit of SAR (W/kg)	10 g Average	1 g Average	Power Drift (dB)
	2.0	1.6	
Test Case Of Body	Measurement Result (W/kg)		
	10 g Average	1 g Average	
High frequency (See Figure 11)	0.827	1.280	0.127
Mid frequency (See Figure 9)	0.786	1.220	0.029
Low frequency (See Figure 13)	0.800	1.230	0.070

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**Table 12: SAR Values [GSM 850 GPRS (different timeslots) at Test Position 1 with IBM X41, Middle frequency]**

Liquid Temperature: 22.2°C			
Limit of SAR (W/kg)	10 g Average	1 g Average	Power Drift (dB)
	2.0	1.6	
Test Case Of Body	Measurement Result (W/kg)		
	10 g Average	1 g Average	
2 timeslots in uplink (See Figure 9)	0.786	1.220	0.029
1 timeslot in uplink (See Figure 15)	0.572	0.880	0.064

**Table 13: SAR Values [GSM 850 GPRS (2 timeslots in uplink) at different Test Position with IBM X41, Middle frequency]**

Liquid Temperature: 22.2°C			
Limit of SAR (W/kg)	10 g Average	1 g Average	Power Drift (dB)
	2.0	1.6	
Test Case Of Body	Measurement Result (W/kg)		
	10 g Average	1 g Average	
Test Position 1 (See Figure 9)	0.786	1.220	0.029
Test Position 2 (See Figure 17)	0.145	0.213	-0.141
Test Position 3 (See Figure 19)	0.033	0.119	-0.072

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**Table 14: SAR Values [GSM 850 EGPRS (different timeslots) at Test Position 1 with IBM X41, Middle frequency]**

Liquid Temperature: 22.4°C			
Limit of SAR (W/kg)	10 g Average	1 g Average	Power Drift (dB)
	2.0	1.6	
Test Case Of Body	Measurement Result (W/kg)		
	10 g Average	1 g Average	
4 timeslots in uplink(See Figure 21)	0.100	0.156	0.057
3 timeslots in uplink(See Figure 23)	0.143	0.232	-0.137
2 timeslots in uplink(See Figure 25)	0.208	0.324	-0.002
1 timeslot in uplink(See Figure 27)	0.177	0.276	0.084

**Table 15: SAR Values (GSM 850 GPRS for 2 timeslots in uplink at different Position with BenQ R55V, Mid frequency)**

Liquid Temperature: 22.4°C			
Limit of SAR (W/kg)	10 g Average	1 g Average	Power Drift (dB)
	2.0	1.6	
Test Case Of Body	Measurement Result (W/kg)		
	10 g Average	1 g Average	
Test Position 3 (See Figure 29)	0.124	0.397	-0.119
Test Position 4 (See Figure 31)	0.236	0.379	0.029
Test Position 5 (See Figure 33)	0.149	0.215	0.058
Test Position 6 (See Figure 35)	0.334	0.479	-0.154

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**Table 16: SAR Values [GSM 1900 GPRS (2 timeslots in uplink) at Test position 1 with different model computer, Middle frequency)**

Liquid Temperature: 22.3°C			
Limit of SAR (W/kg)	10 g Average	1 g Average	Power Drift (dB)
	2.0	1.6	
Test Case Of Body	Measurement Result (W/kg)		
	10 g Average	1 g Average	
With BenQ Joy book S72 (See Figure 37)	0.334	0.572	-0.173
With IBM X41 (See Figure 39)	0.419	0.789	-0.149

**Table 17: SAR Values [GSM 1900 GPRS (different timeslots) at Test position 1 with IBM X41, Middle frequency)**

Liquid Temperature: 22.6°C			
Limit of SAR (W/kg)	10 g Average	1 g Average	Power Drift (dB)
	2.0	1.6	
Test Case Of Body	Measurement Result (W/kg)		
	10 g Average	1 g Average	
2 timeslots in uplink(See Figure 39)	0.419	0.789	-0.149
1 timeslot in uplink(See Figure 41)	0.306	0.550	0.012

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**Table 18: SAR Values [GSM 1900 GPRS (2 timeslots in uplink) at different Test Position with IBM X41, Middle frequency]**

Liquid Temperature: 22.4°C			
Limit of SAR (W/kg)	10 g Average	1 g Average	Power Drift (dB)
	2.0	1.6	
Test Case Of Body	Measurement Result (W/kg)		
	10 g Average	1 g Average	
Test Position 1 (See Figure 39)	0.419	0.789	-0.149
Test Position 2 (See Figure 43)	0.182	0.323	-0.175
Test Position 3 (See Figure 45)	0.385	0.904	-0.190

**Table 19 SAR Values [GSM 1900 EGPRS (different timeslots) at Test Position 3 with IBM X41, Middle frequency]**

Liquid Temperature: 22.4°C			
Limit of SAR (W/kg)	10 g Average	1 g Average	Power Drift (dB)
	2.0	1.6	
Test Case Of Body	Measurement Result (W/kg)		
	10 g Average	1 g Average	
4 timeslots in uplink(See Figure 47)	0.076	0.159	-0.192
3 timeslots in uplink(See Figure 49)	0.125	0.269	-0.053
2 timeslots in uplink(See Figure 51)	0.149	0.339	-0.094
1 timeslot in uplink(See Figure 53)	0.108	0.233	0.195

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**Table 20: SAR Values [GSM 1900 GPRS (2 timeslots in uplink) at different Position with BenQ R55V, Mid frequency)**

Liquid Temperature: 22.4°C			
Limit of SAR (W/kg)	10 g Average	1 g Average	Power Drift (dB)
	2.0	1.6	
Test Case Of Body	Measurement Result (W/kg)		
	10 g Average	1 g Average	
Test Position 3 (See Figure 55)	0.322	0.745	-0.045
Test Position 4 (See Figure 57)	0.148	0.262	-0.141
Test Position 5 (See Figure 59)	0.137	0.229	-0.006
Test Position 6 (See Figure 61)	0.285	0.518	0.071

#### 8.4 Conclusion

Localized Specific Absorption Rate (SAR) of this portable wireless device has been measured in all cases requested by the relevant standards cited in Clause 5.2 of this report. Maximum localized SAR is below exposure limits specified in the relevant standards cited in Clause 5.1 of this test report.

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### 9 Measurement Uncertainty

No.	a	Type	c	d	e= f(d, k)	f	h=c×f / e	k
	Uncertainty Component		Tol. (±%)	Prob. Dist	Div.	c <sub>1</sub> (1g)	1g u (±%)	v <sub>1</sub>
1	System repetivity	A	0.5	N	1	1	0.5	9
Measurement system								
2	Probe Calibration	B	5	N	2	1	2.5	∞
3	Axial isotropy	B	4.7	R	$\sqrt{3}$	$(1-c_p)^{1/2}$	4.3	∞
4	Hemisphere Isotropy	B	9.4	R	$\sqrt{3}$	$\sqrt{C_P}$		∞
5	Boundary Effect	B	0.4	R	$\sqrt{3}$	1	0.23	∞
6	Linearity	B	4.7	R	$\sqrt{3}$	1	2.7	∞
7	System Detection Limits	B	1.0	R	$\sqrt{3}$	1	0.6	∞
8	Readout Electronics	B	1.0	N	1	1	1.0	∞
9	RF Ambient Conditions	B	3.0	R	$\sqrt{3}$	1	1.73	∞
10	Probe Positioner Mechanical Tolerance	B	0.4	R	$\sqrt{3}$	1	0.2	∞
11	Probe Positioning with respect to Phantom Shell	B	2.9	R	$\sqrt{3}$	1	1.7	∞
12	Extrapolation, interpolation and Integration Algorithms for Max. SAR Evaluation	B	3.9	R	$\sqrt{3}$	1	2.3	∞
Test Sample Related								
13	Test Sample Positioning	A	4.9	N	1	1	4.9	N-1
14	Device Holder Uncertainty	A	6.1	N	1	1	6.1	N-1
15	Output Power Variation-SAR drift measurement	B	5.0	R	$\sqrt{3}$	1	2.9	∞
Phantom and Tissue Parameters								
16	Phantom Uncertainty(shape and thickness tolerances)	B	1.0	R	$\sqrt{3}$	1	0.6	∞
17	Liquid Conductivity-deviation from target values	B	5.0	R	$\sqrt{3}$	0.64	1.7	∞
18	Liquid Conductivity-measurement uncertainty	B	5.0	N	1	0.64	1.7	M
19	Liquid Permittivity-deviation from target values	B	5.0	R	$\sqrt{3}$	0.6	1.7	∞

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20	Liquid Permittivity- measurement uncertainty	B	5.0	N	1	0.6	1.7	M
Combined Standard Uncertainty				RSS			11.25	
Expanded Uncertainty (95 % CONFIDENCE INTERVAL)				K=2			22.5	

## 10 MAIN TEST INSTRUMENTS

**Table 21: List of Main Instruments**

No.	Name	Type	Serial Number	Calibration Date	Valid Period
01	Network analyzer	Agilent 8753E	US37390326	September 15, 2007	One year
02	Dielectric Probe Kit	Agilent 85070E	US44020115	No Calibration Requested	
03	Power meter	Agilent E4417A	GB41291714	January 25, 2007	One year
04	Power sensor	Agilent 8481H	MY41091316	January 25, 2007	One year
05	Signal Generator	HP 8341B	2730A00804	September 15, 2007	One year
06	Amplifier	IXA-020	0401	No Calibration Requested	
07	Validation Kit 835MHz	SPEAG D835V2	443	February 19, 2007	Two years
08	Validation Kit 1900MHz	SPEAG D1900V2	541	February 20, 2007	Two years
09	BTS	E5515C	GB46490218	December 16, 2006	One year
10	E-field Probe	ET3DV6	1737	February 20, 2007	One year
11	DAE	DAE3	452	September 6, 2007	One year

## 11 TEST PERIOD

The test is performed from Sep. 26<sup>th</sup>, 2007 to Sep.27<sup>th</sup>, 2007 and Oct. 19<sup>th</sup>, 2007.

## 12 TEST LOCATION

The test is performed at TA Technology (Shanghai) Co., Ltd.

\*\*\*END OF REPORT BODY\*\*\*

## ANNEX A: MEASUREMENT PROCESS

The evaluation was performed with the following procedure:

Step 1: Measurement of the SAR value at a fixed location above the ear point was measured and was used as a reference value for assessing the power drop.

Step 2: The SAR distribution at the exposed side of the head was measured at a distance of 3.9 mm from the inner surface of the shell. The area covered the entire dimension of the head and the horizontal grid spacing was 20 mm x 20 mm. Based on this data, the area of the maximum absorption was determined by spline interpolation.

Step 3: Around this point, a volume of 32 mm x 32 mm x 34 mm was assessed by measuring 7 x 7 x 7 points. On this basis of this data set, the spatial peak SAR value was evaluated with the following procedure:

a. The data at the surface were extrapolated, since the center of the dipoles is 2.7 mm away from the tip of the probe and the distance between the surface and the lowest measuring point is 1.2 mm. The extrapolation was based on a least square algorithm. A polynomial of the fourth order was calculated through the points in z-axes. This polynomial was then used to evaluate the points between the surface and the probe tip.

b. The maximum interpolated value was searched with a straightforward algorithm. Around this maximum the SAR values averaged over the spatial volumes (1g or 10g) were computed using the 3D-Spline interpolation algorithm. The 3D-spline is composed of three one-dimensional splines with the "Not a knot"-condition (in x ~ y and z-directions). The volume was integrated with the trapezoidal algorithm. One thousand points (10 x 10 x 10) were interpolated to calculate the average.

c. All neighboring volumes were evaluated until no neighboring volume with a higher average value was found.

Step 4: Re-measurement the SAR value at the same location as in Step 1. If the value changed by more than 5%, the evaluation is repeated.

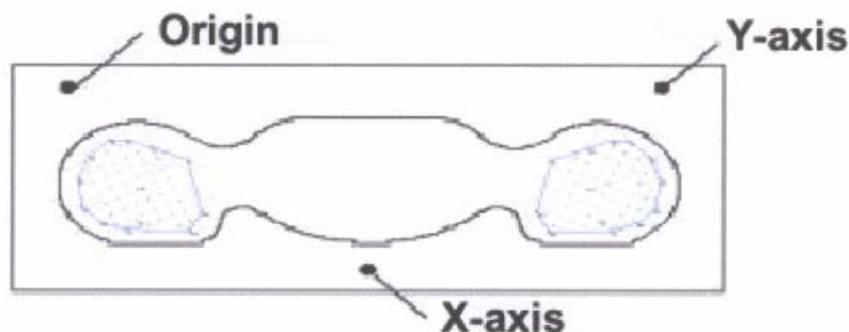
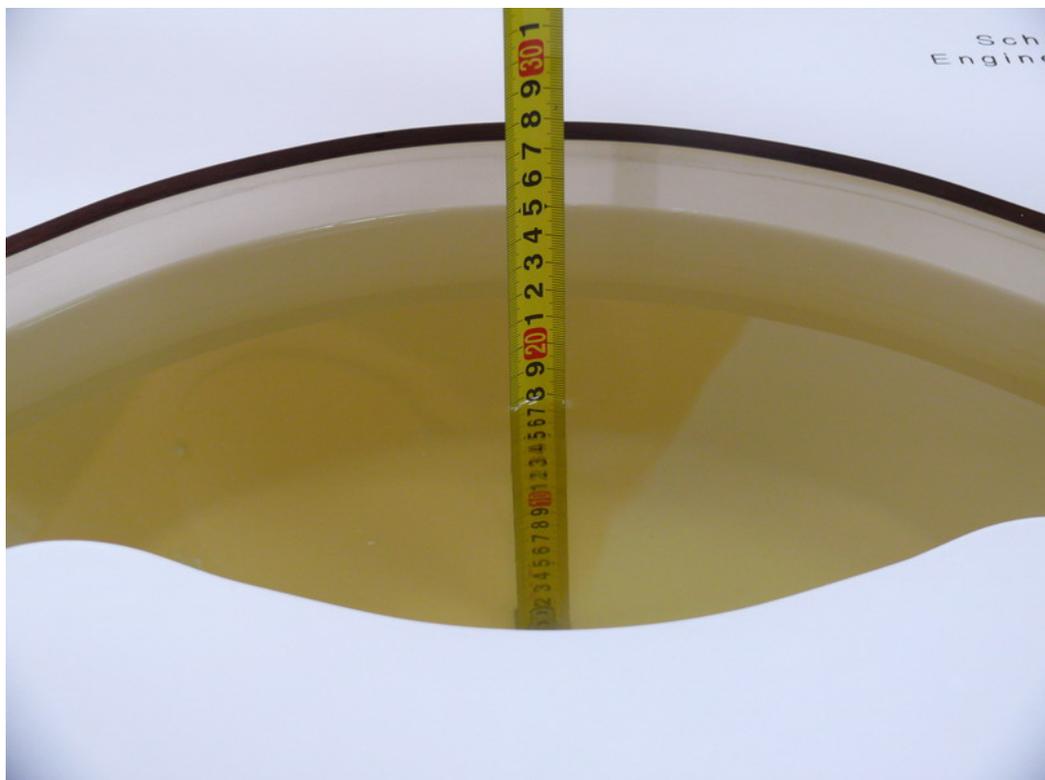


Figure 6 SAR Measurement Points in Area Scan

## ANNEX B: TEST LAYOUT



Picture 5 Specific Absorption Rate Test Layout



Picture 6 Liquid depth in the Flat Phantom (GSM850 )



Picture 7 Liquid depth in the Flat Phantom (GSM1900)

## ANNEX C: GRAPH RESULTS

### GSM 850 GPRS with BenQ Joy book S72 Middle Test Position 1

Communication System: GSM850 + GPRS (2Up); Frequency: 836.6 MHz; Duty Cycle: 1:4

Medium: Body 850MHz

Medium parameters used:  $f = 837$  MHz;  $\sigma = 0.991$  mho/m;  $\epsilon_r = 55.2$ ;  $\rho = 1000$  kg/m<sup>3</sup>

- Probe: ET3DV6 - SN1737; ConvF(6.52, 6.52, 6.52);

- Electronics: DAE3 Sn452;

**Test Position 1 Middle/Area Scan (61x91x1):** Measurement grid: dx=15mm, dy=15mm

Maximum value of SAR (interpolated) = 0.905 mW/g

**Test Position 1 Middle/Zoom Scan (7x7x7)/Cube 0:** Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 25.5 V/m; Power Drift = -0.001 dB

Peak SAR (extrapolated) = 1.18 W/kg

**SAR(1 g) = 0.836 mW/g; SAR(10 g) = 0.551 mW/g**

Maximum value of SAR (measured) = 0.843 mW/g

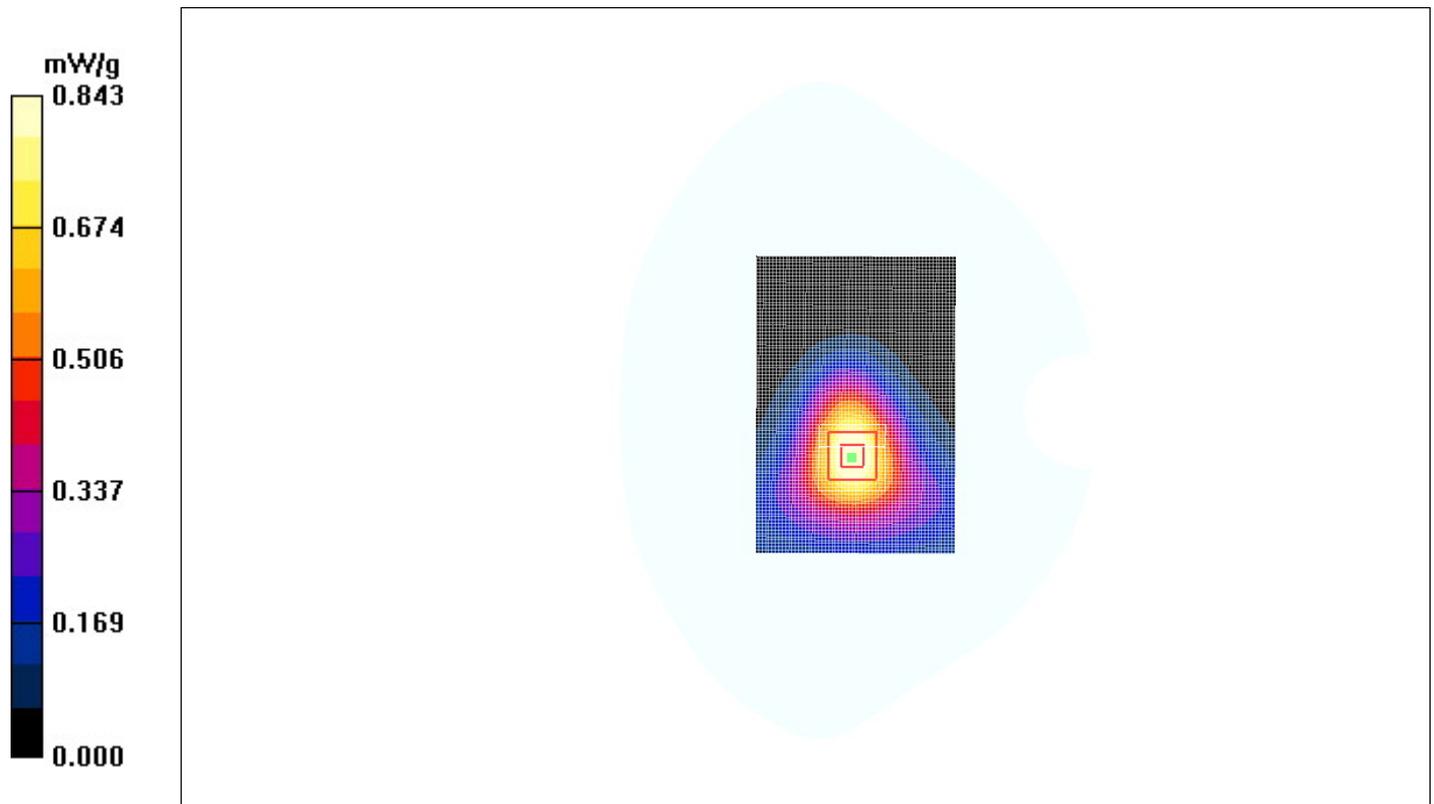


Figure 7 GSM 850 GPRS with BenQ Joy book S72 Test Position1 CH190 (2 timeslots in uplink)

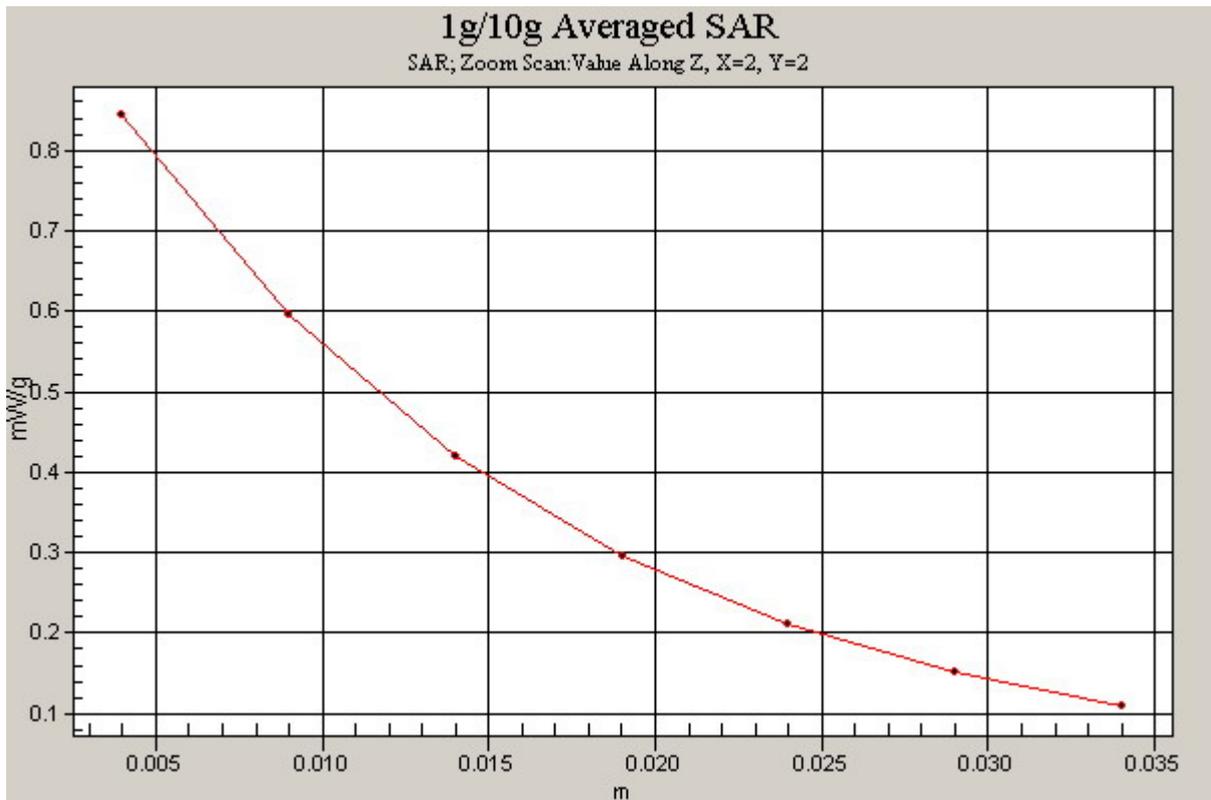


Figure 8 Z-Scan at power reference point [GSM 850 GPRS with BenQ Joy book S72 Test Position 1 CH190 (2 timeslots in uplink)]

**GSM 850 GPRS with IBM X41 Middle Test Position1 (2 timeslots in uplink)**

Communication System: GSM850 + GPRS (2Up); Frequency: 836.6 MHz; Duty Cycle: 1:4

Medium: Body 850MHz

Medium parameters used:  $f = 837$  MHz;  $\sigma = 0.991$  mho/m;  $\epsilon_r = 55.2$ ;  $\rho = 1000$  kg/m<sup>3</sup>

- Probe: ET3DV6 - SN1737; ConvF(6.52, 6.52, 6.52);

- Electronics: DAE3 Sn452;

**Test Position 1 Middle/Area Scan (61x91x1):** Measurement grid: dx=15mm, dy=15mm

Maximum value of SAR (interpolated) = 1.36 mW/g

**Test Position 1 Middle/Zoom Scan (7x7x7)/Cube 0:** Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 33.3 V/m; Power Drift = 0.029 dB

Peak SAR (extrapolated) = 1.70 W/kg

**SAR(1 g) = 1.22 mW/g; SAR(10 g) = 0.786 mW/g**

Maximum value of SAR (measured) = 1.34 mW/g

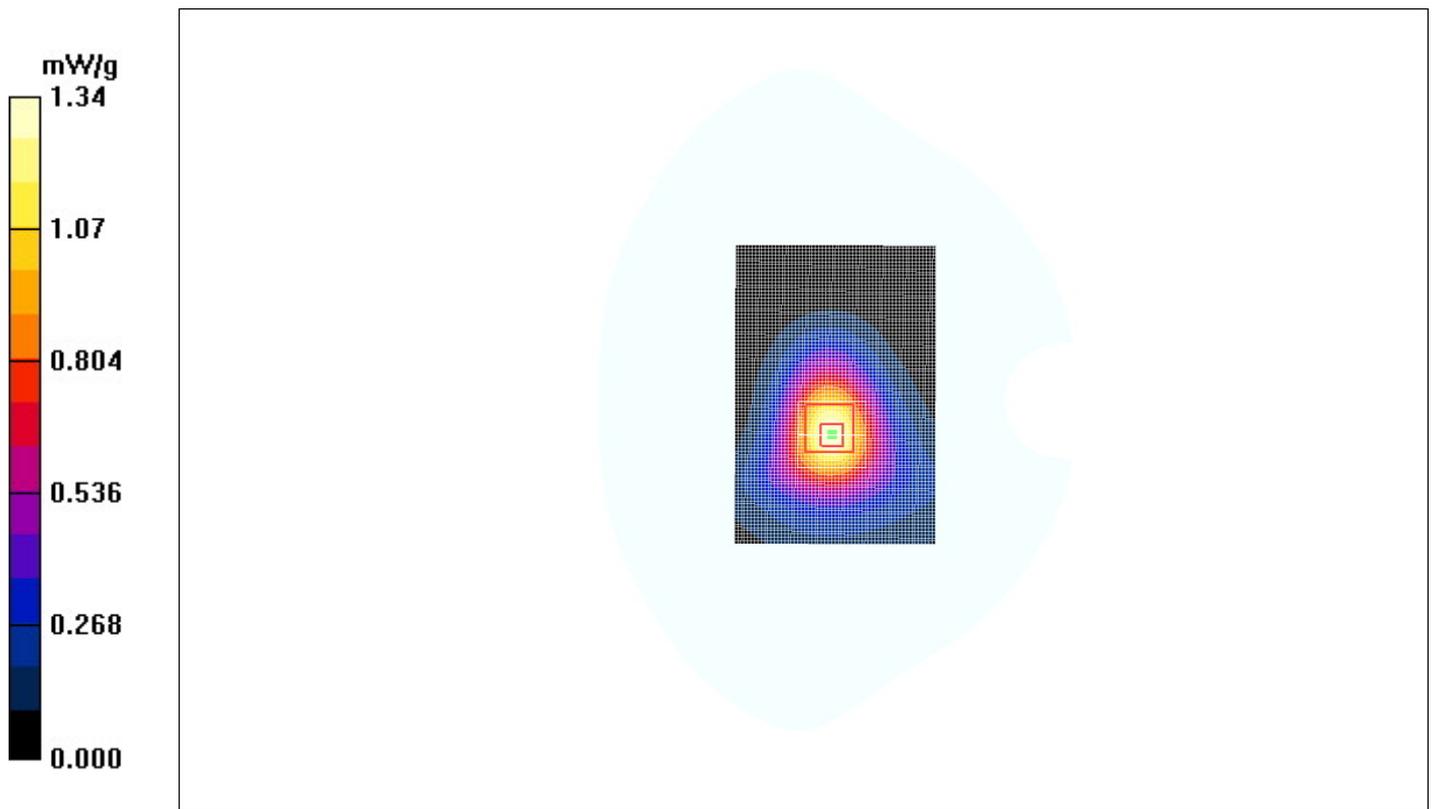


Figure 9 GSM 850 GPRS with IBM X41 Test Position 1 CH190 (2 timeslots in uplink)

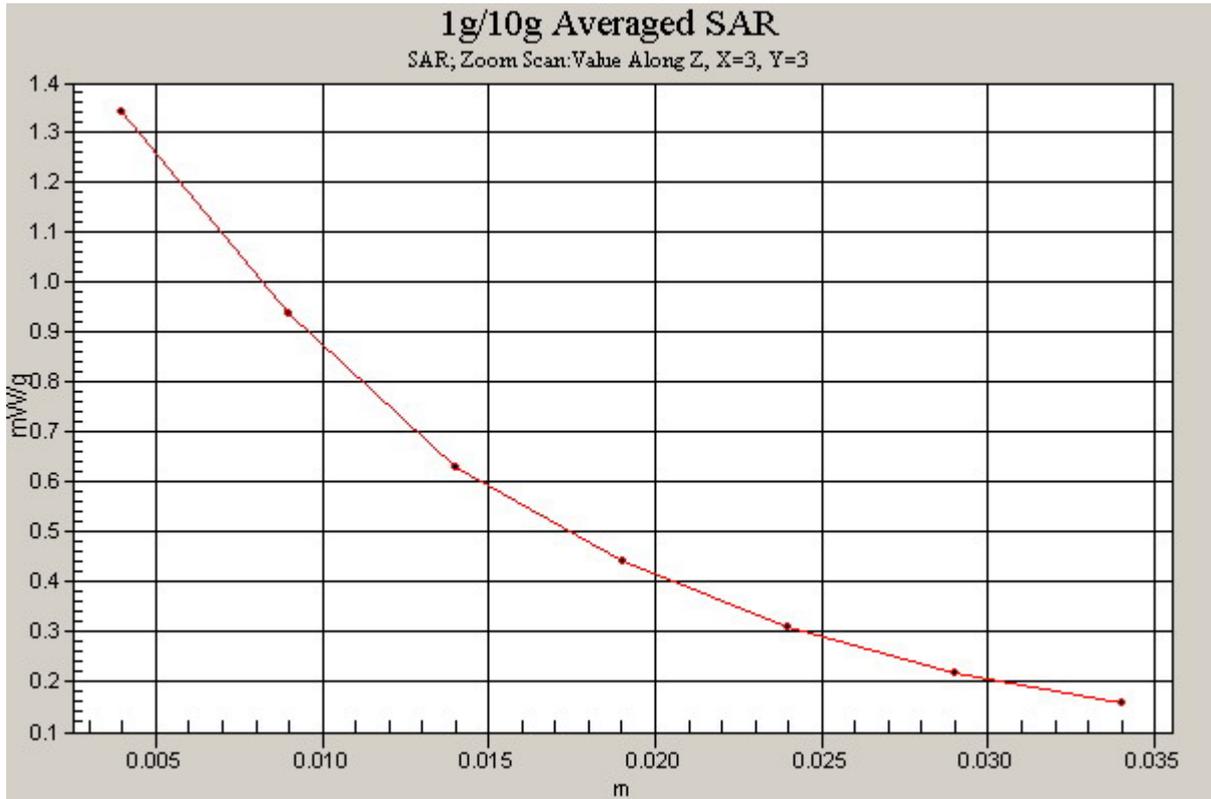


Figure 10 Z-Scan at power reference point [GSM 850 GPRS with IBM X41 Test Position1 CH190  
(2 timeslots in uplink)]

**GSM 850 GPRS with IBM X41 High Test Position 1 (2 timeslots in uplink)**

Communication System: GSM850 + GPRS (2Up); Frequency: 848.8 MHz; Duty Cycle: 1:4

Medium: Body 850MHz

Medium parameters used:  $f = 849$  MHz;  $\sigma = 1$  mho/m;  $\epsilon_r = 55$ ;  $\rho = 1000$  kg/m<sup>3</sup>

- Probe: ET3DV6 - SN1737; ConvF(6.52, 6.52, 6.52);

- Electronics: DAE3 Sn452;

**Test Position 1 High/Area Scan (61x91x1):** Measurement grid: dx=15mm, dy=15mm

Maximum value of SAR (interpolated) = 1.42 mW/g

**Test Position 1 High/Zoom Scan (7x7x7)/Cube 0:** Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 33.2 V/m; Power Drift = 0.127 dB

Peak SAR (extrapolated) = 1.81 W/kg

**SAR(1 g) = 1.28 mW/g; SAR(10 g) = 0.827 mW/g**

Maximum value of SAR (measured) = 1.32 mW/g

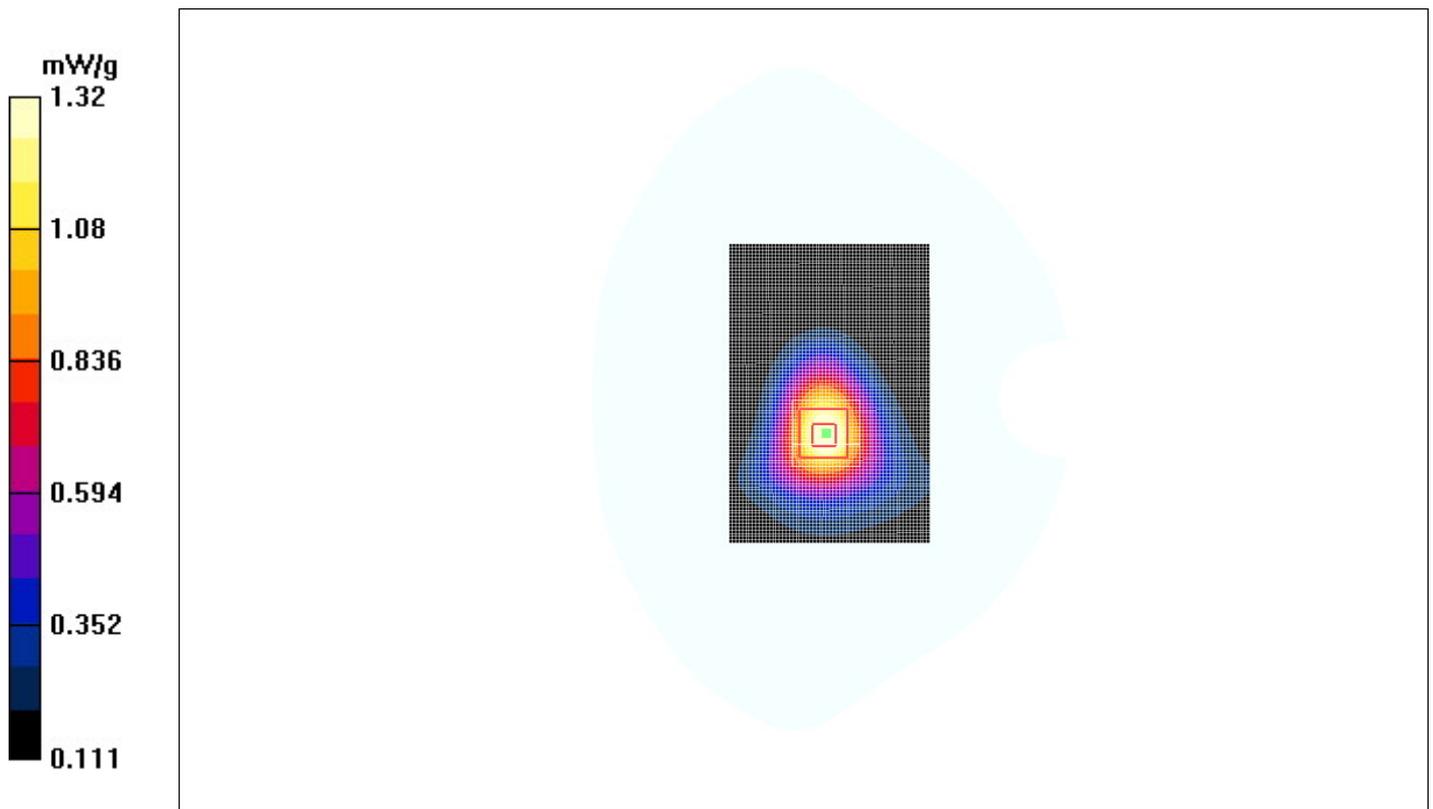


Figure 11 GSM 850 GPRS with IBM X41 Test Position 1 CH251 (2 timeslots in uplink)

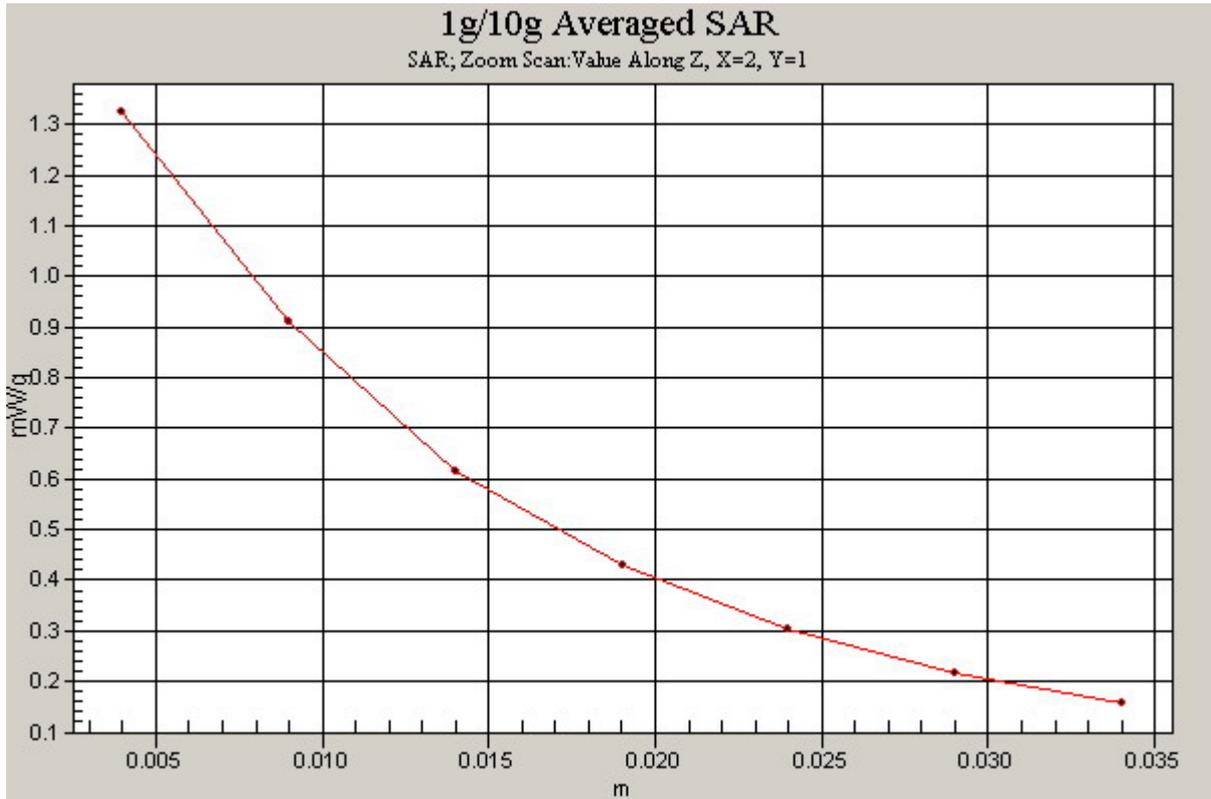


Figure 12 Z-Scan at power reference point [GSM 850 GPRS with IBM X41 Test Position1 CH251 (2 timeslots in uplink)]

**GSM 850 GPRS with IBM X41 Low Test Position 1 (2 timeslots in uplink)**

Communication System: GSM850 + GPRS (2Up); Frequency: 824.2 MHz; Duty Cycle: 1:4

Medium: Body 850MHz

Medium parameters used (interpolated):  $f = 824.2$  MHz;  $\sigma = 0.987$  mho/m;  $\epsilon_r = 55.2$ ;  $\rho = 1000$  kg/m<sup>3</sup>

- Probe: ET3DV6 - SN1737; ConvF(6.52, 6.52, 6.52);

- Electronics: DAE3 Sn452;

**Test Position 1 Low/Area Scan (61x91x1):** Measurement grid: dx=15mm, dy=15mm

Maximum value of SAR (interpolated) = 1.37 mW/g

**Test Position 1 Low/Zoom Scan (7x7x7)/Cube 0:** Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 33.7 V/m; Power Drift = 0.070 dB

Peak SAR (extrapolated) = 1.73 W/kg

**SAR(1 g) = 1.23 mW/g; SAR(10 g) = 0.800 mW/g**

Maximum value of SAR (measured) = 1.25 mW/g

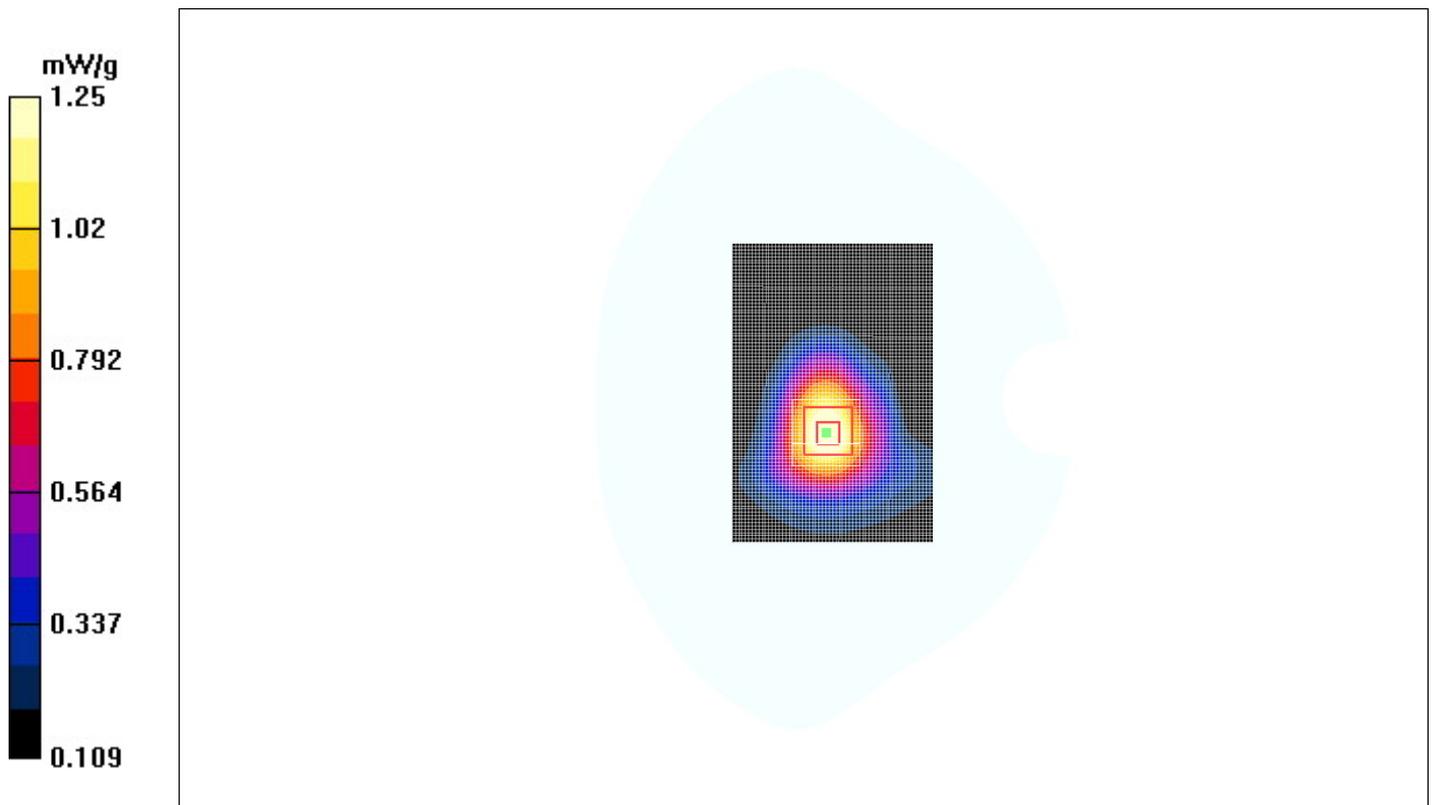


Figure 13 GSM 850 GPRS with IBM X41 Test Position 1 CH128 (2 timeslots in uplink)

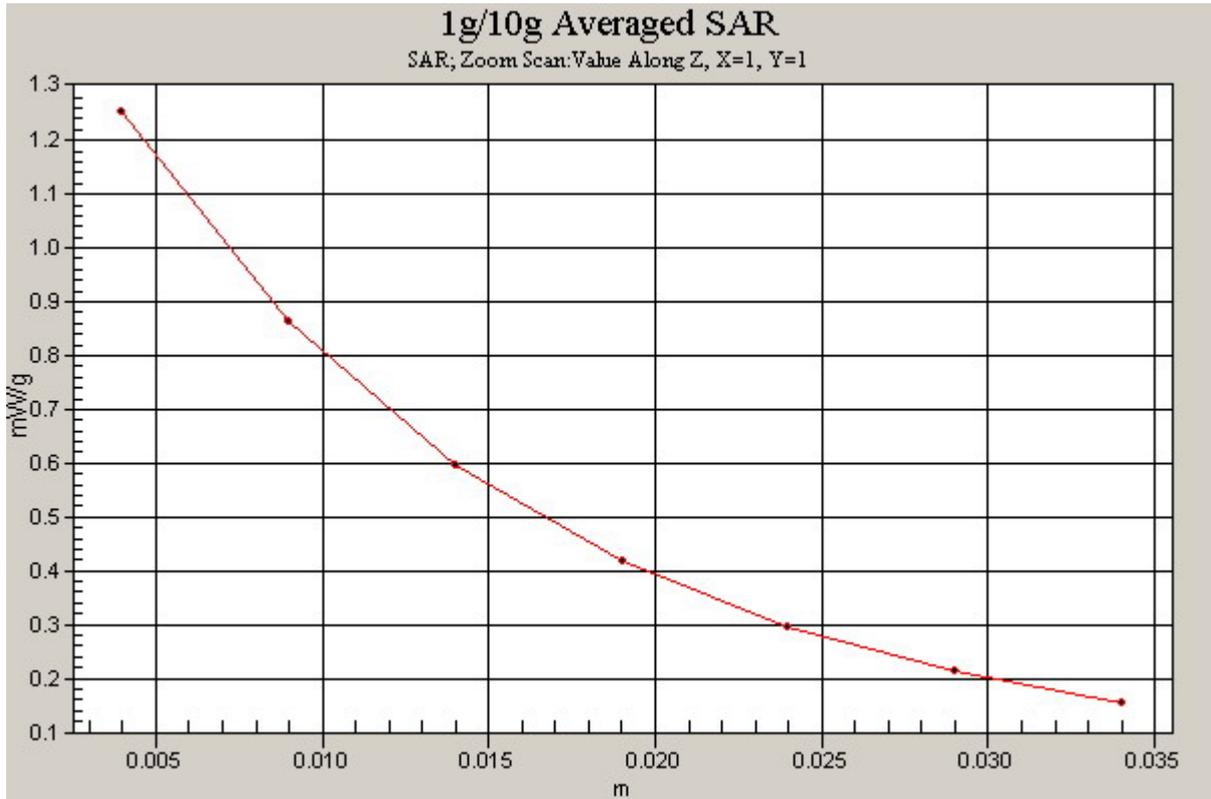


Figure 14 Z-Scan at power reference point [GSM 850 GPRS with IBM X41 Test Position1 CH128 (2 timeslots in uplink)]

**GSM 850 GPRS with IBM X41 Middle Test Position 1 (1 timeslot in uplink)**

Communication System: GSM850 + GPRS (1Up); Frequency: 836.6 MHz; Duty Cycle: 1:8

Medium: Body 850MHz

Medium parameters used:  $f = 837$  MHz;  $\sigma = 0.991$  mho/m;  $\epsilon_r = 55.2$ ;  $\rho = 1000$  kg/m<sup>3</sup>

- Probe: ET3DV6 - SN1737; ConvF(6.52, 6.52, 6.52);

- Electronics: DAE3 Sn452;

**Test Position 1 Middle/Area Scan (61x91x1):** Measurement grid: dx=15mm, dy=15mm

Maximum value of SAR (interpolated) = 0.952 mW/g

**Test Position 1 Middle/Zoom Scan (7x7x7)/Cube 0:** Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 25.0 V/m; Power Drift = 0.064 dB

Peak SAR (extrapolated) = 1.27 W/kg

**SAR(1 g) = 0.880 mW/g; SAR(10 g) = 0.572 mW/g**

Maximum value of SAR (measured) = 0.952 mW/g

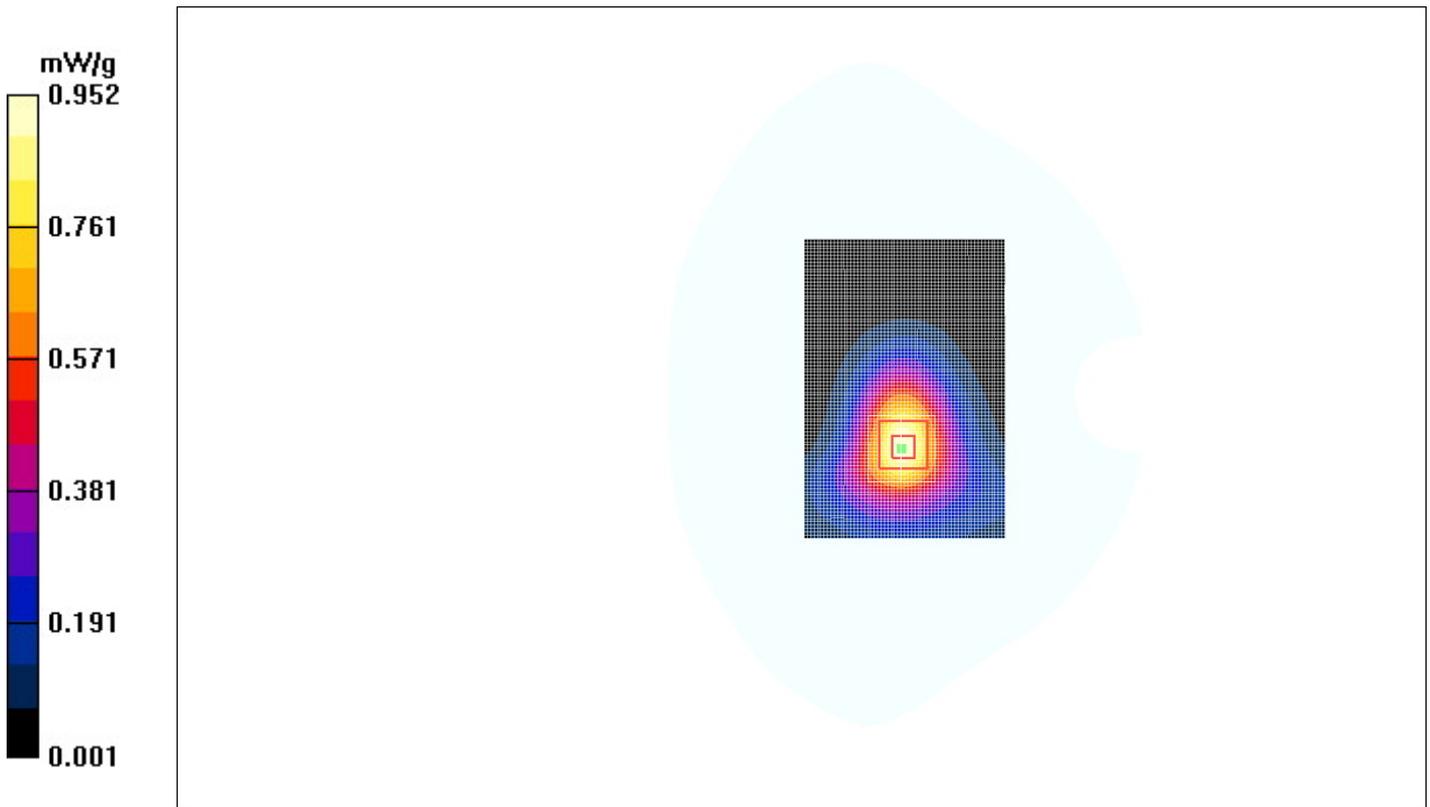


Figure 15 GSM 850 GPRS with IBM X41 Test Position 1 CH190 (1 timeslot in uplink)



Figure 16 Z-Scan at power reference point [GSM 850 GPRS with IBM X41 Test Position 1  
CH190 (1 timeslot in uplink)]

**GSM 850 GPRS with IBM X41 Middle Test Position 2 (2 timeslots in uplink)**

Communication System: GSM850 + GPRS (2Up); Frequency: 836.6 MHz; Duty Cycle: 1:4

Medium: Body 850 MHz

Medium parameters used:  $f = 837$  MHz;  $\sigma = 0.991$  mho/m;  $\epsilon_r = 55.2$ ;  $\rho = 1000$  kg/m<sup>3</sup>

- Probe: ET3DV6 - SN1737; ConvF(6.52, 6.52, 6.52);

- Electronics: DAE3 Sn452;

**Test Position 2 Middle/Area Scan (61x91x1):** Measurement grid: dx=15mm, dy=15mm

Maximum value of SAR (interpolated) = 0.233 mW/g

**Test Position 2 Middle/Zoom Scan (7x7x7)/Cube 0:** Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 13.0 V/m; Power Drift = -0.141 dB

Peak SAR (extrapolated) = 0.290 W/kg

**SAR(1 g) = 0.213 mW/g; SAR(10 g) = 0.145 mW/g**

Maximum value of SAR (measured) = 0.230 mW/g

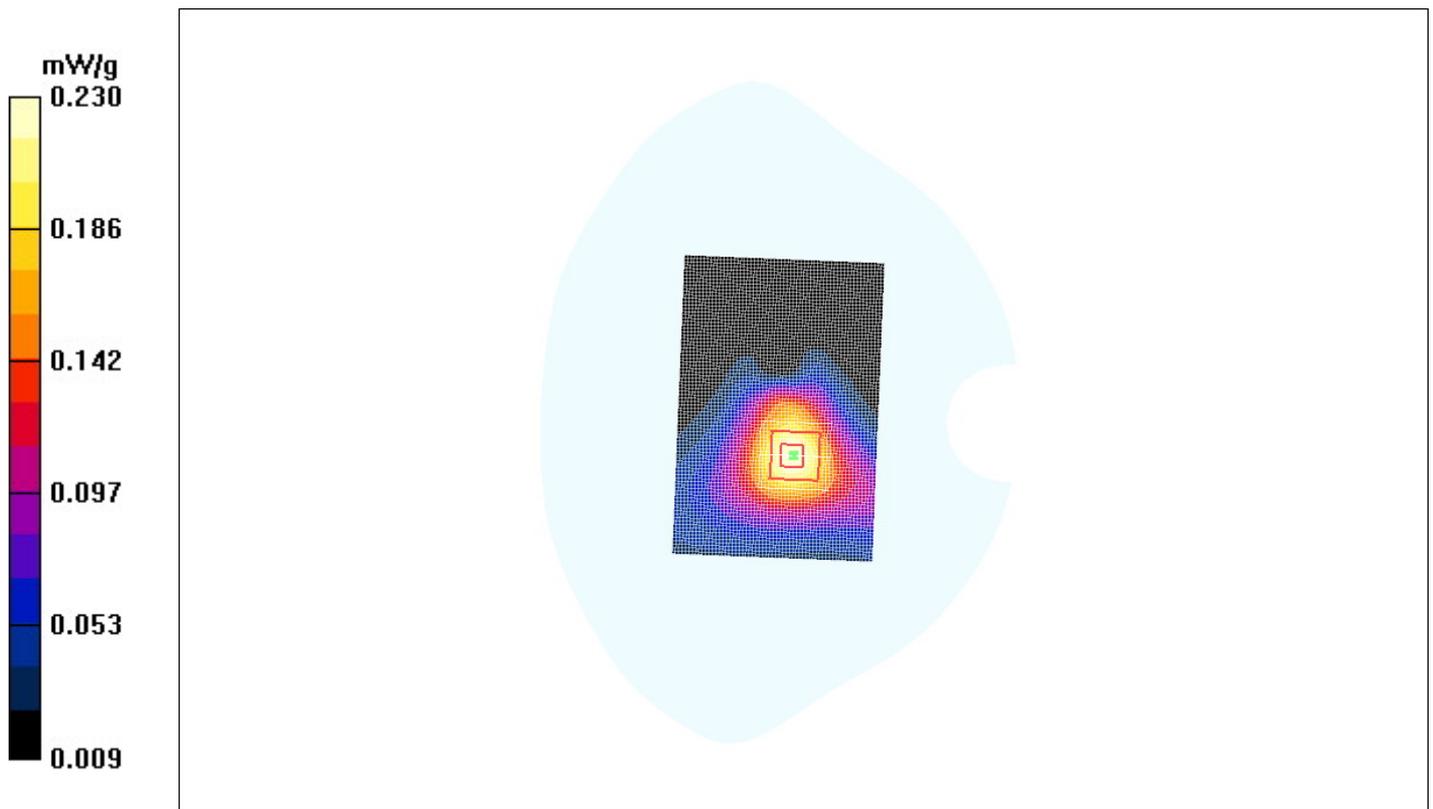


Figure 17 GSM 850 GPRS with IBM X41 Test Position 2 CH190 (2 timeslots in uplink)

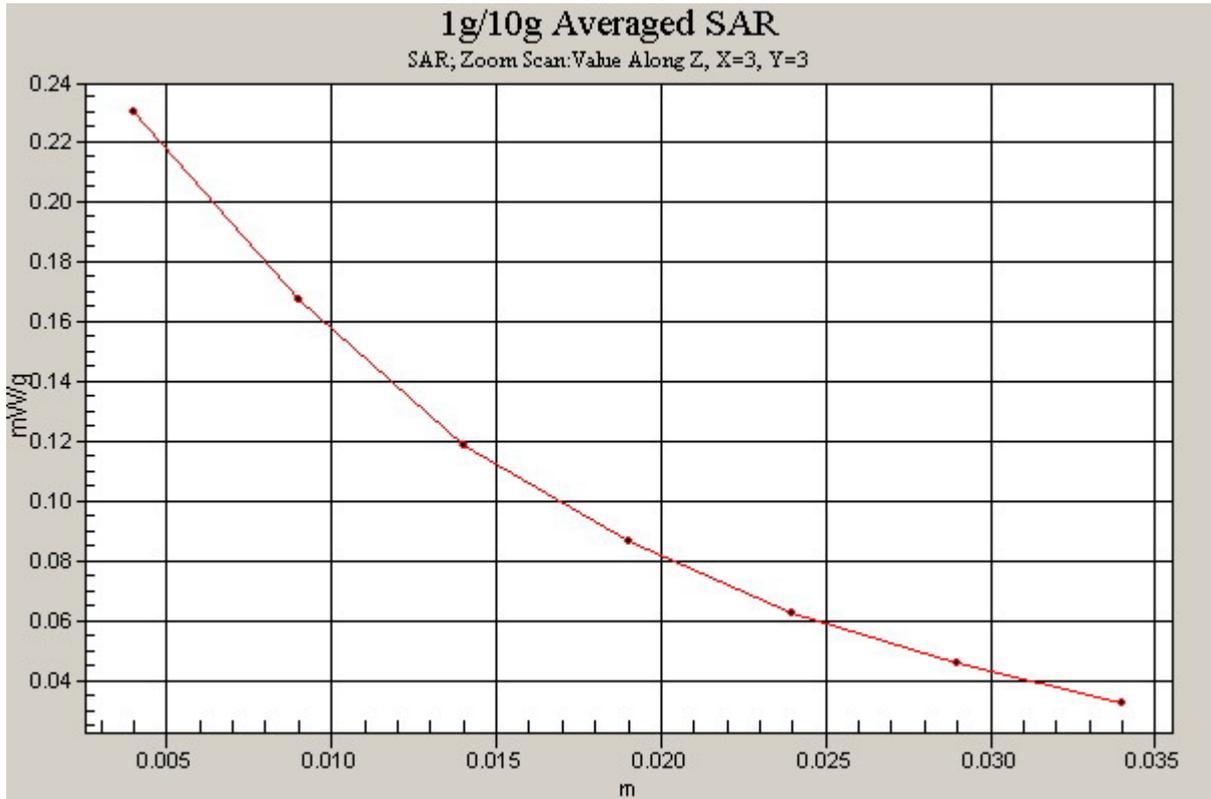


Figure 18 Z-Scan at power reference point [GSM 850 GPRS with IBM X41 Test Position 2  
CH190 (2 timeslots in uplink)]

**GSM 850 GPRS with IBM X41 Middle Test Position 3 (2 timeslots in uplink)**

Communication System: GSM850 + GPRS (2Up); Frequency: 836.6 MHz; Duty Cycle: 1:4

Medium: Body 850MHz

Medium parameters used:  $f = 837$  MHz;  $\sigma = 0.991$  mho/m;  $\epsilon_r = 55.2$ ;  $\rho = 1000$  kg/m<sup>3</sup>

- Probe: ET3DV6 - SN1737; ConvF(6.52, 6.52, 6.52);

- Electronics: DAE3 Sn452;

**Test Position 3 Middle/Area Scan (51x51x1):** Measurement grid: dx=15mm, dy=15mm

Maximum value of SAR (interpolated) = 0.058 mW/g

**Test Position 3 Middle/Zoom Scan (7x7x7)/Cube 0:** Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 11.5 V/m; Power Drift = -0.072 dB

Peak SAR (extrapolated) = 0.722 W/kg

**SAR(1 g) = 0.119 mW/g; SAR(10 g) = 0.033 mW/g**

Maximum value of SAR (measured) = 0.127 mW/g

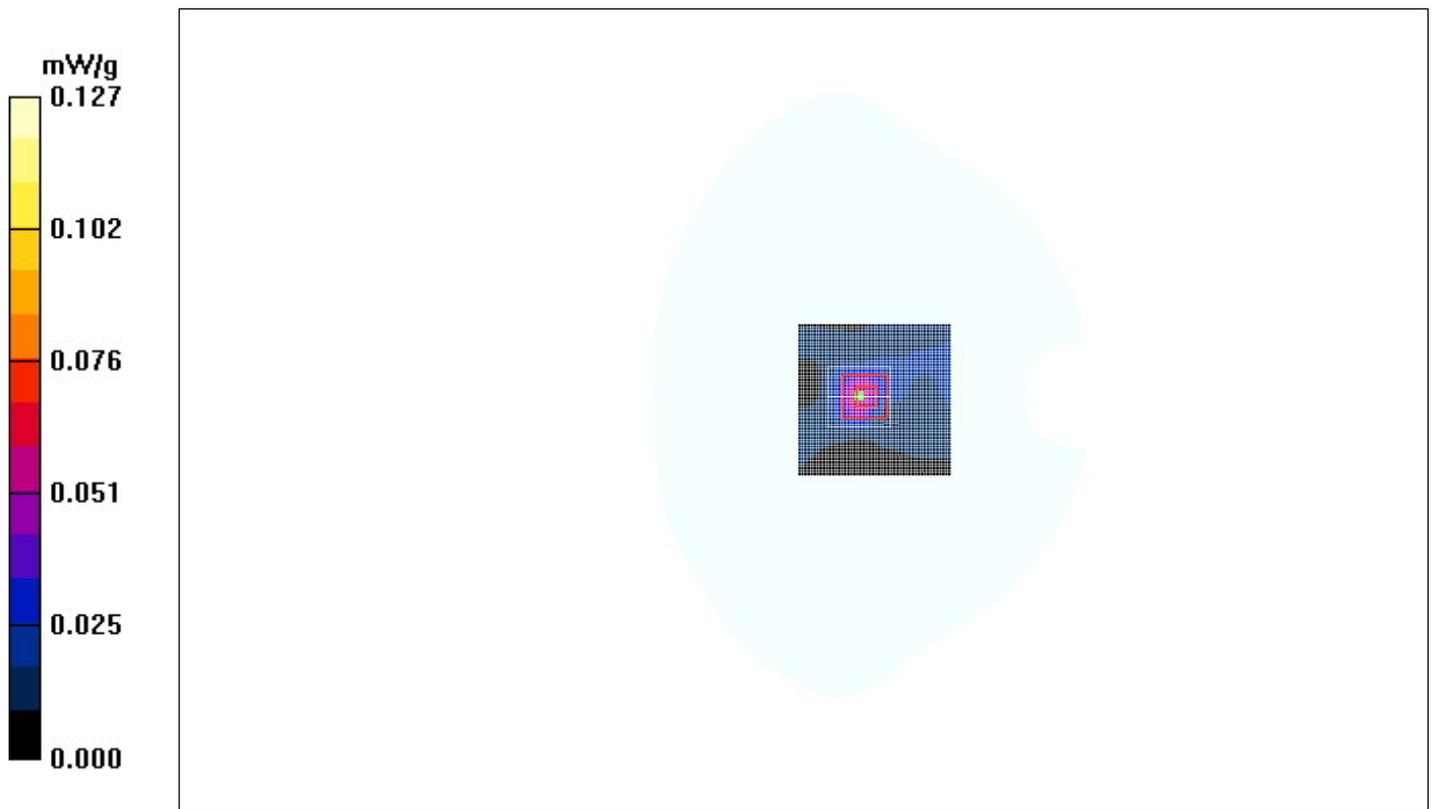


Figure 19 GSM 850 GPRS with IBM X41 Test Position 3 CH190 (2 timeslots in uplink)

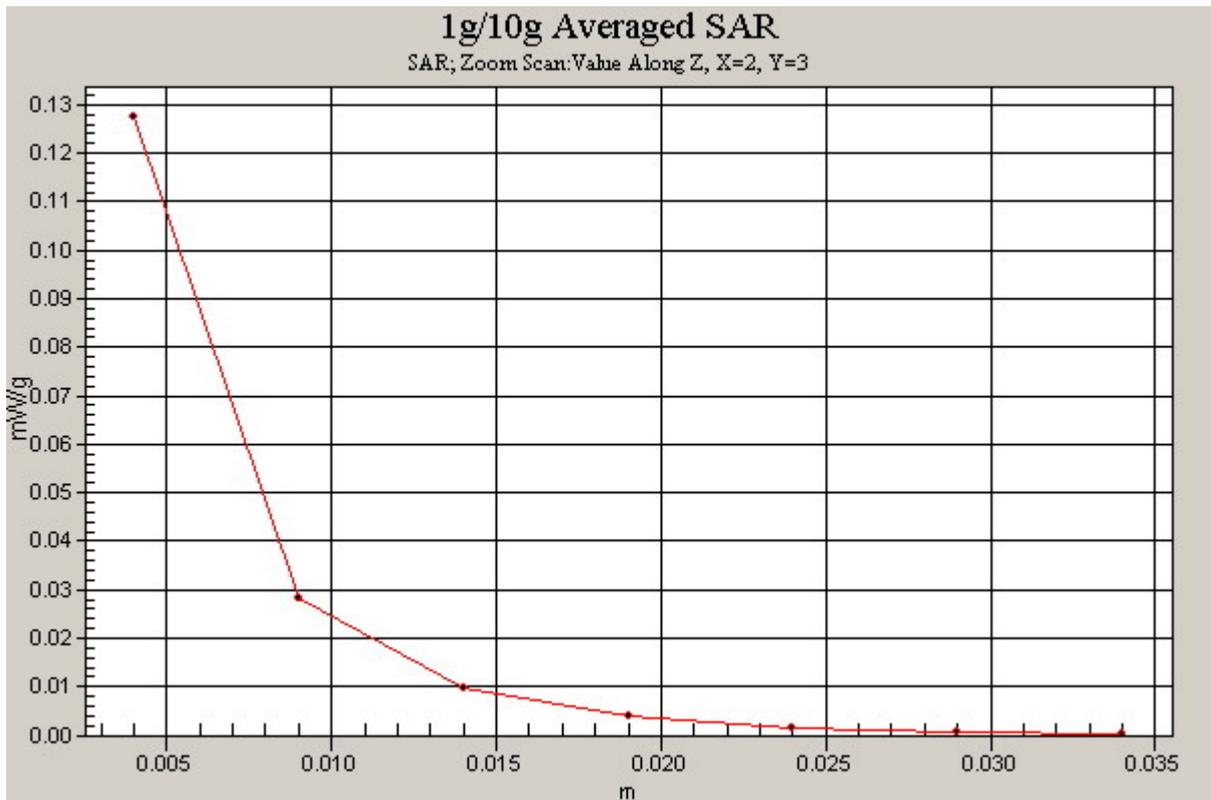


Figure 20 Z-Scan at power reference point [GSM 850 GPRS with IBM X41 Test Position 3  
CH190 (2 timeslots in uplink)]

**GSM 850 EGPRS with IBM X41 Middle Test position 1 (4 timeslots in uplink)**

Communication System: GSM850 + EGPRS (4Up); Frequency: 836.6 MHz; Duty Cycle: 1:2

Medium: Body 850MHz

Medium parameters used:  $f = 837$  MHz;  $\sigma = 0.991$  mho/m;  $\epsilon_r = 55.2$ ;  $\rho = 1000$  kg/m<sup>3</sup>

- Probe: ET3DV6 - SN1737; ConvF(6.52, 6.52, 6.52);

- Electronics: DAE3 Sn452;

**Test position 1 Middle/Area Scan (41x91x1):** Measurement grid: dx=15mm, dy=15mm

Maximum value of SAR (interpolated) = 0.167 mW/g

**Test position 1 Middle/Zoom Scan (7x7x7)/Cube 0:** Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 11.0 V/m; Power Drift = 0.057 dB

Peak SAR (extrapolated) = 0.221 W/kg

**SAR(1 g) = 0.156 mW/g; SAR(10 g) = 0.100 mW/g**

Maximum value of SAR (measured) = 0.161 mW/g

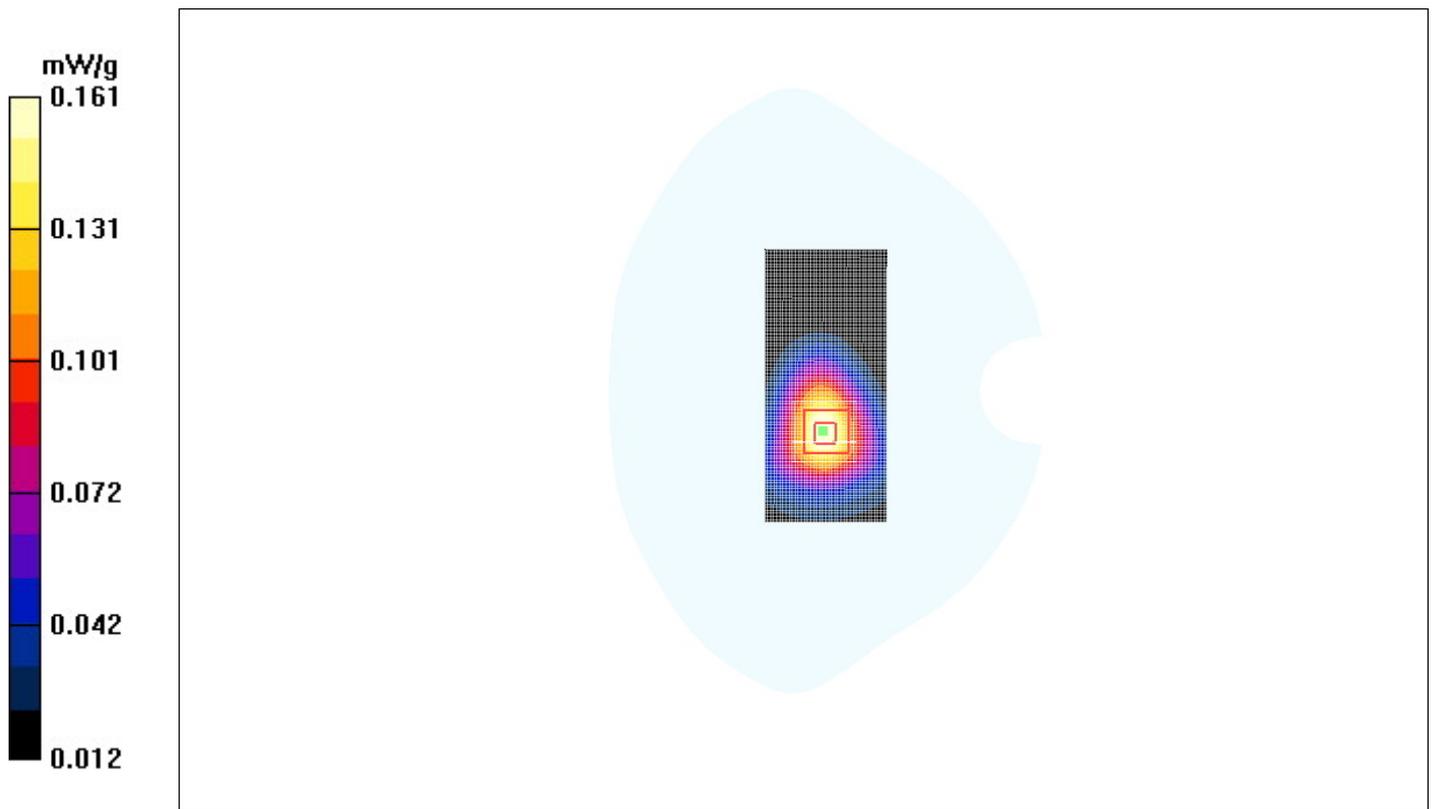


Figure 21 GSM 850 EGPRS with IBM X41 Test Position 1 CH190 (4 timeslots in uplink)

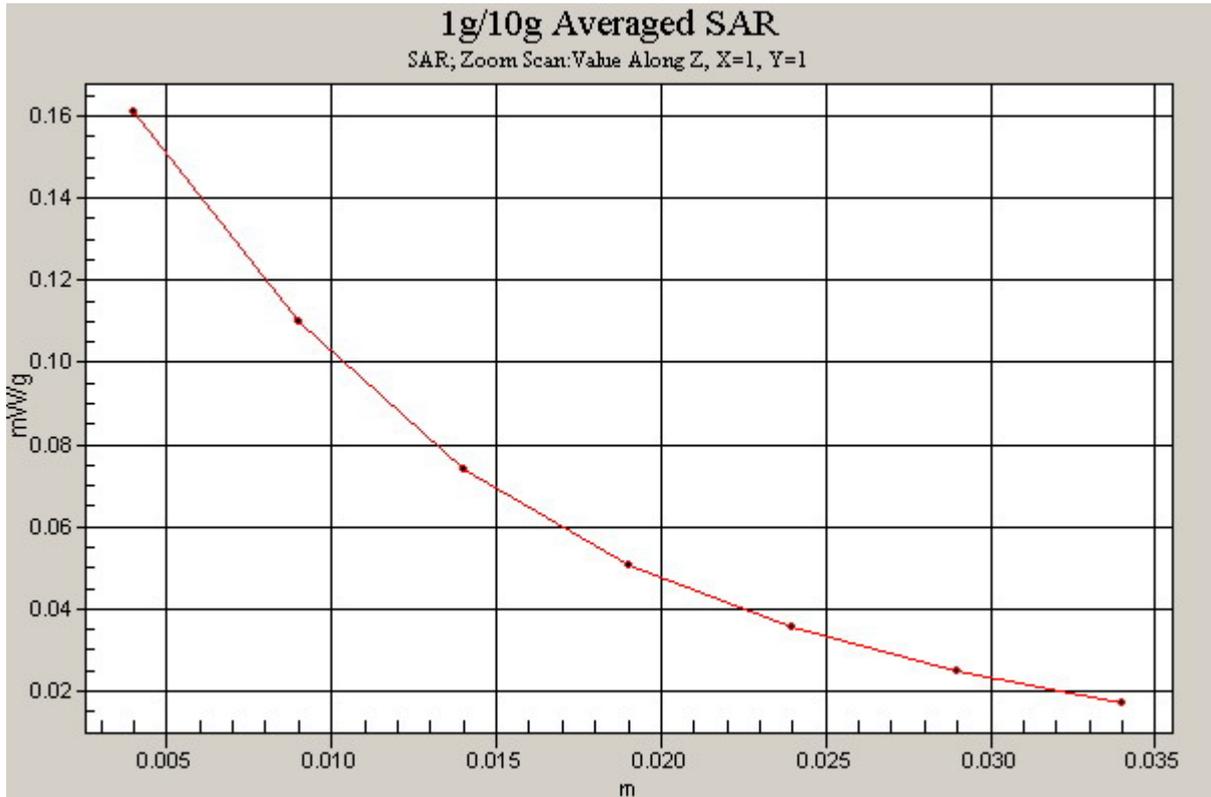


Figure 22 Z-Scan at power reference point [GSM 850 EGPRS with IBM X41 Test Position 1 CH190 (4 timeslots in uplink)]

**GSM 850 EGPRS with IBM X41 Middle Test position 1 (3 timeslots in uplink)**

Communication System: GSM850 + EGPRS (3Up); Frequency: 836.6 MHz; Duty Cycle: 1:2.67

Medium: Body 850MHz

Medium parameters used:  $f = 837$  MHz;  $\sigma = 0.991$  mho/m;  $\epsilon_r = 55.2$ ;  $\rho = 1000$  kg/m<sup>3</sup>

- Probe: ET3DV6 - SN1737; ConvF(6.52, 6.52, 6.52);

- Electronics: DAE3 Sn452;

**Test position 1 Middle/Area Scan (41x91x1):** Measurement grid: dx=15mm, dy=15mm

Maximum value of SAR (interpolated) = 0.244 mW/g

**Test position 1 Middle/Zoom Scan (7x7x7)/Cube 0:** Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 13.2 V/m; Power Drift = -0.137 dB

Peak SAR (extrapolated) = 0.348 W/kg

**SAR(1 g) = 0.232 mW/g; SAR(10 g) = 0.143 mW/g**

Maximum value of SAR (measured) = 0.225 mW/g

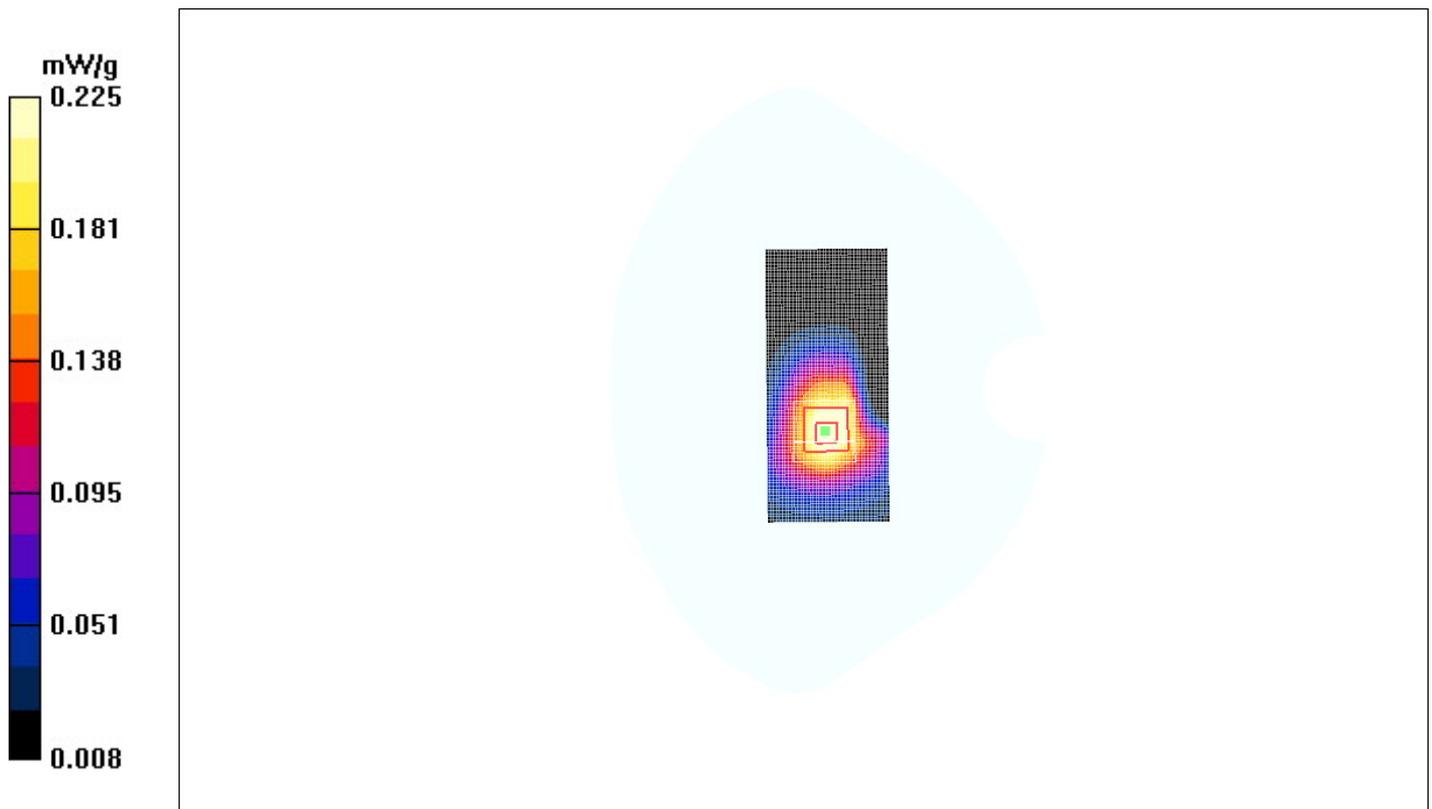


Figure 23 GSM 850 EGPRS with IBM X41 Test Position 1 CH190 (3 timeslots in uplink)

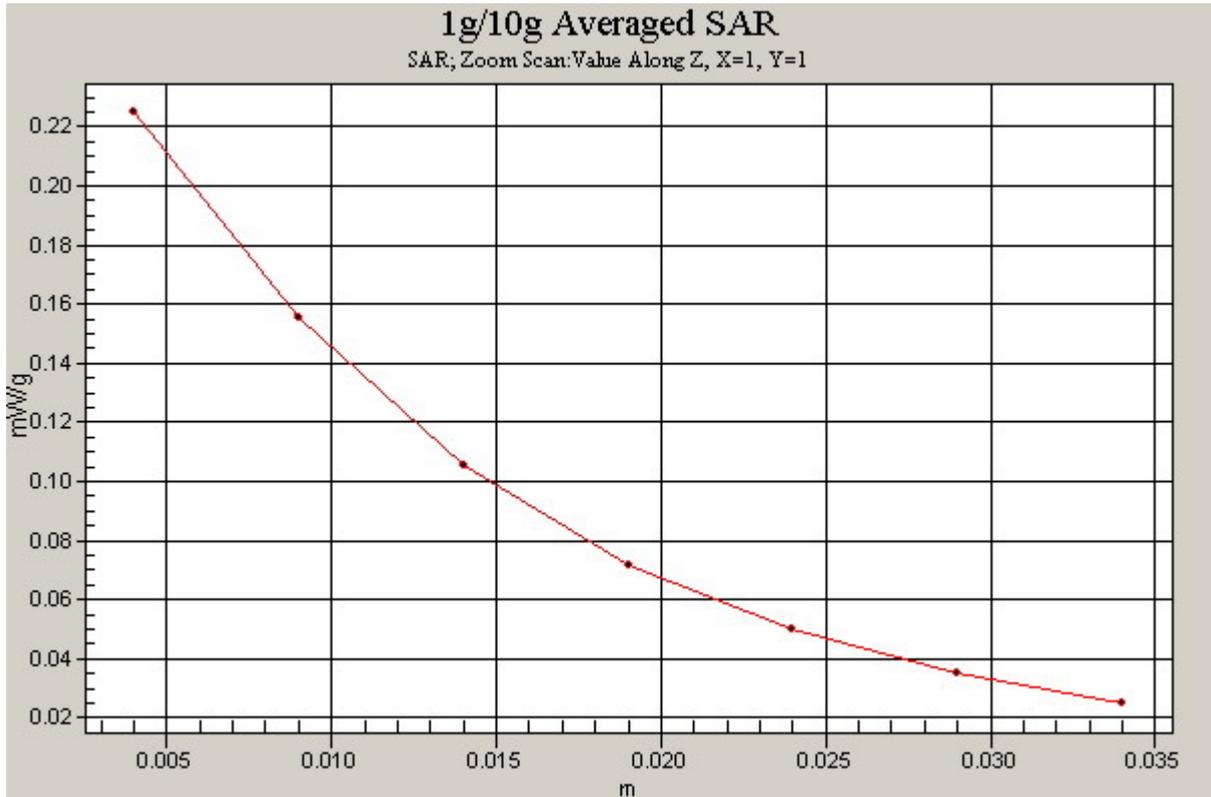


Figure 24 Z-Scan at power reference point [GSM 850 EGPRS with IBM X41 Test Position 1 CH190 (3 timeslots in uplink)]

**GSM 850 EGPRS with IBM X41 Middle Test position 1 (2 timeslots in uplink)**

Communication System: GSM850 + EGPRS (2Up); Frequency: 836.6 MHz; Duty Cycle: 1:4

Medium: Body 850MHz

Medium parameters used:  $f = 837$  MHz;  $\sigma = 0.991$  mho/m;  $\epsilon_r = 55.2$ ;  $\rho = 1000$  kg/m<sup>3</sup>

- Probe: ET3DV6 - SN1737; ConvF(6.52, 6.52, 6.52);

- Electronics: DAE3 Sn452;

**Test position 1 Middle/Area Scan (61x91x1):** Measurement grid: dx=15mm, dy=15mm

Maximum value of SAR (interpolated) = 0.355 mW/g

**Test position 1 Middle/Zoom Scan (7x7x7)/Cube 0:** Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 16.3 V/m; Power Drift = -0.002 dB

Peak SAR (extrapolated) = 0.410 W/kg

**SAR(1 g) = 0.324 mW/g; SAR(10 g) = 0.208 mW/g**

Maximum value of SAR (measured) = 0.333 mW/g

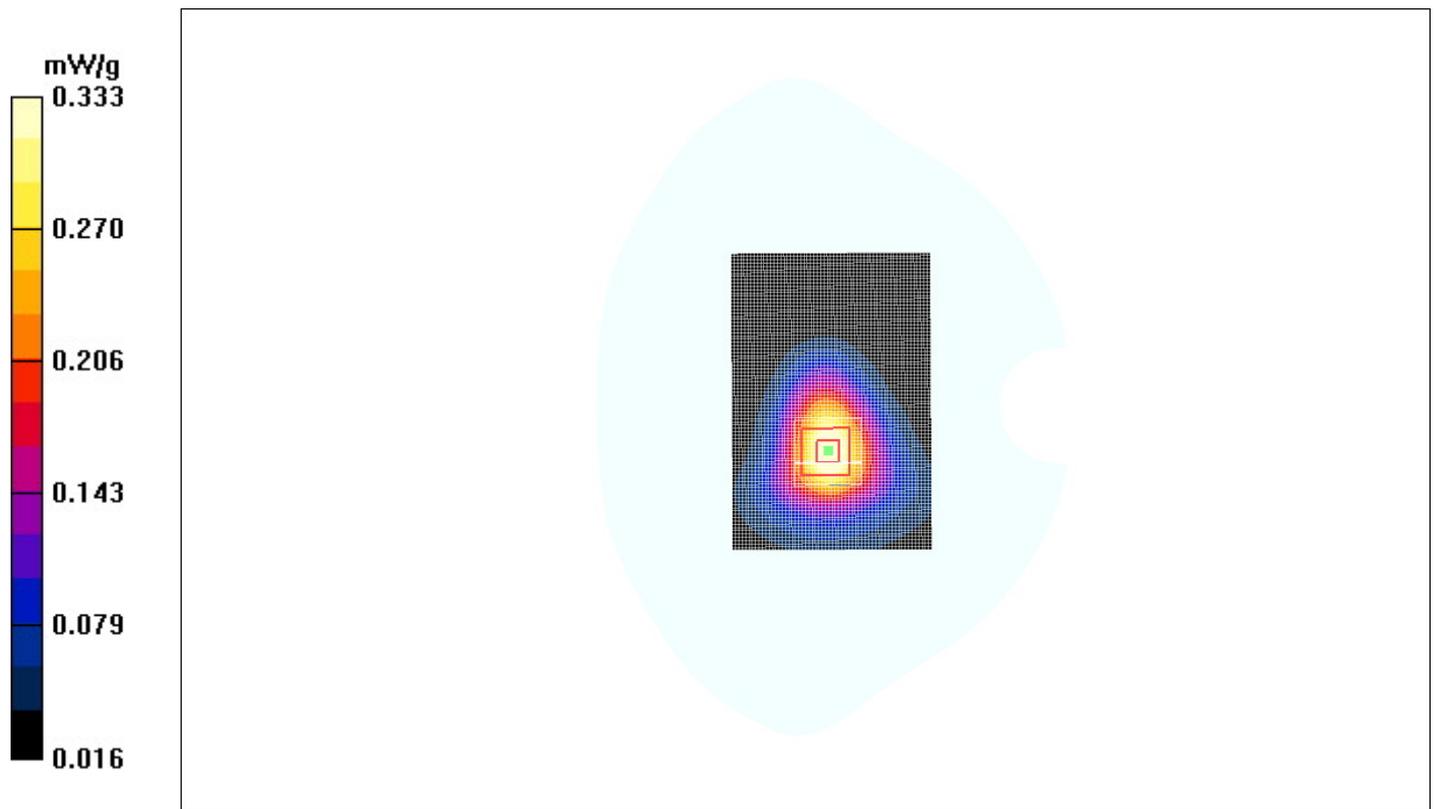


Figure 25 GSM 850 EGPRS with IBM X41 Test Position 1 CH190 (2 timeslots in uplink)

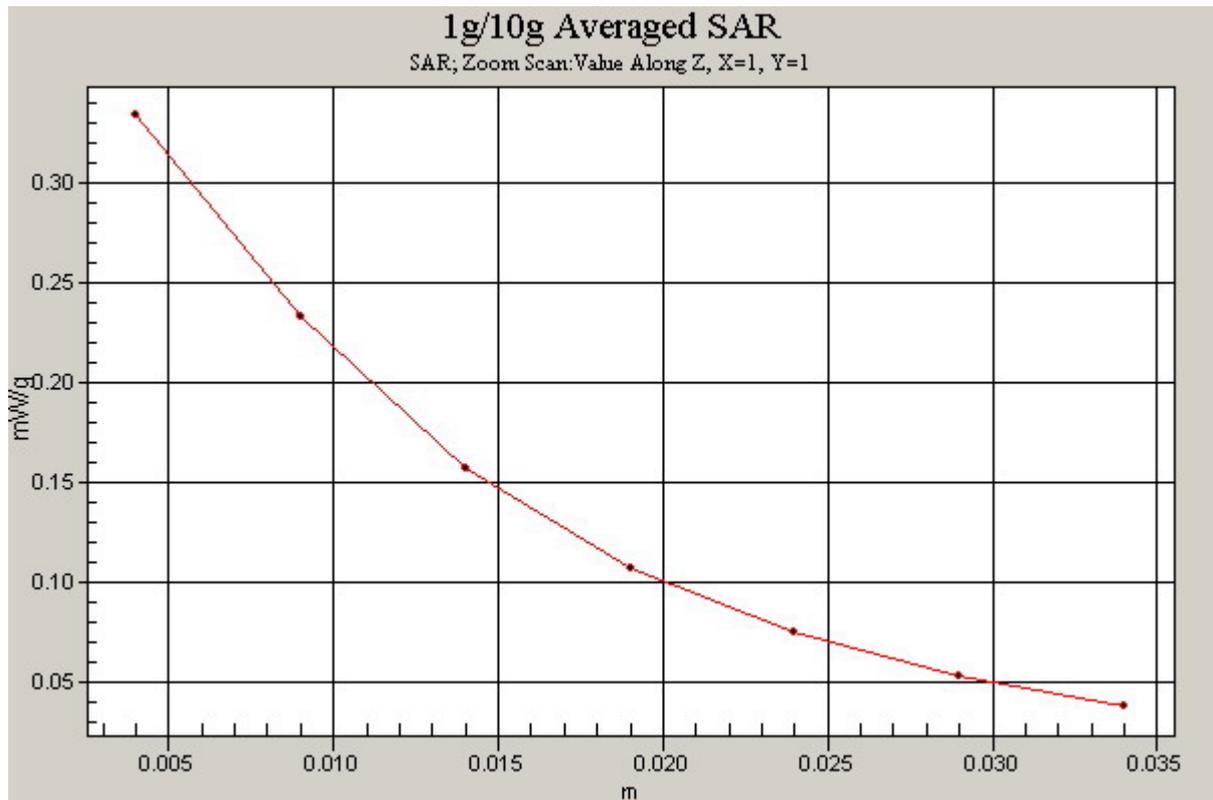


Figure 26 Z-Scan at power reference point [GSM 850 EGPRS with IBM X41 Test Position 1  
CH190 (2 timeslots in uplink)]

**GSM 850 EGPRS with IBM X41 Middle Test position 1 (1 timeslot in uplink)**

Communication System: GSM850 + EGPRS (1Up); Frequency: 836.6 MHz; Duty Cycle: 1:8

Medium: Body 850MHz

Medium parameters used:  $f = 837$  MHz;  $\sigma = 0.991$  mho/m;  $\epsilon_r = 55.2$ ;  $\rho = 1000$  kg/m<sup>3</sup>

- Probe: ET3DV6 - SN1737; ConvF(6.52, 6.52, 6.52);

- Electronics: DAE3 Sn452;

**Test position 1 Middle/Area Scan (41x91x1):** Measurement grid: dx=15mm, dy=15mm

Maximum value of SAR (interpolated) = 0.310 mW/g

**Test position 1 Middle/Zoom Scan (7x7x7)/Cube 0:** Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 14.4 V/m; Power Drift = 0.084 dB

Peak SAR (extrapolated) = 0.388 W/kg

**SAR(1 g) = 0.276 mW/g; SAR(10 g) = 0.177 mW/g**

Maximum value of SAR (measured) = 0.278 mW/g

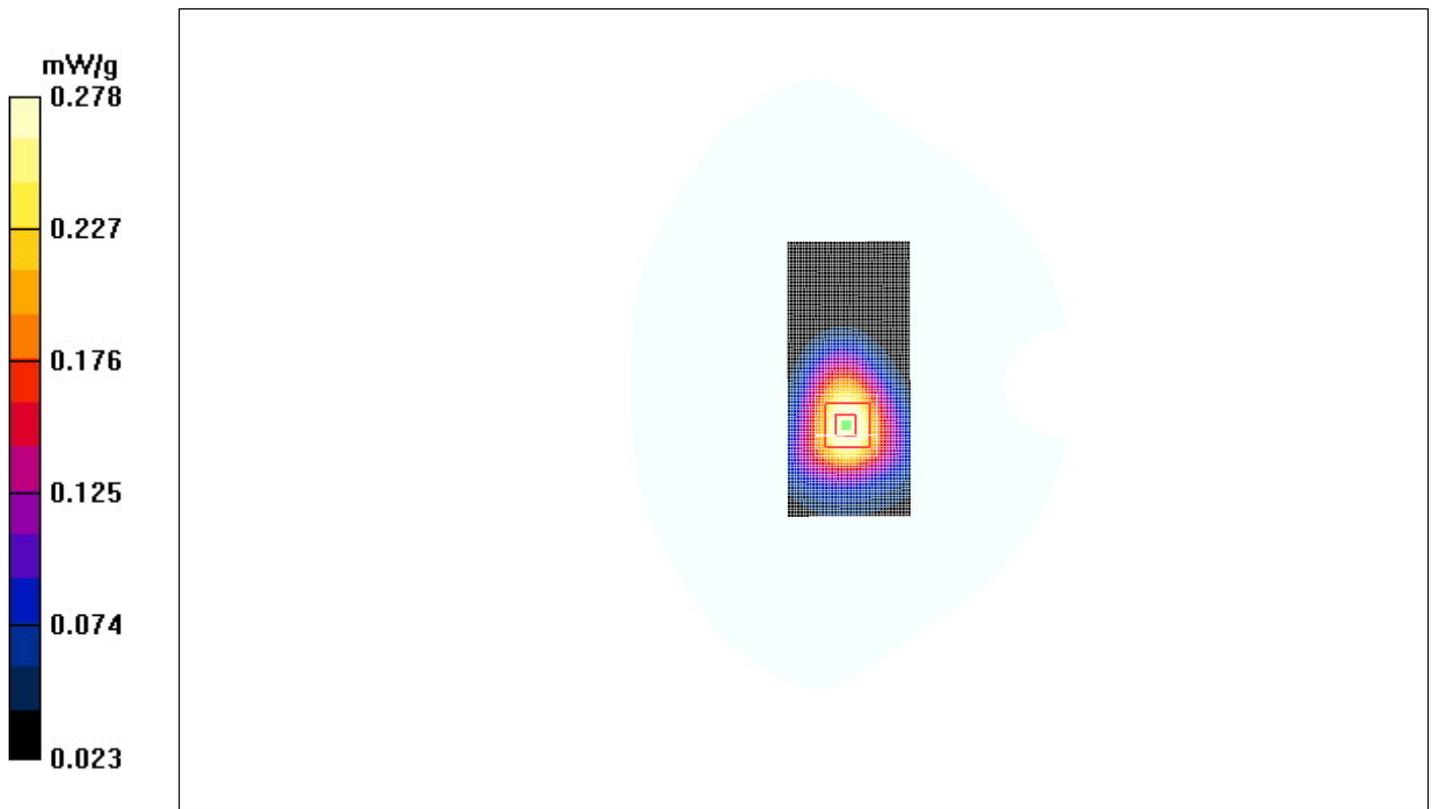


Figure 27 GSM 850 EGPRS with IBM X41 Test Position 1 CH190 (1 timeslot in uplink)

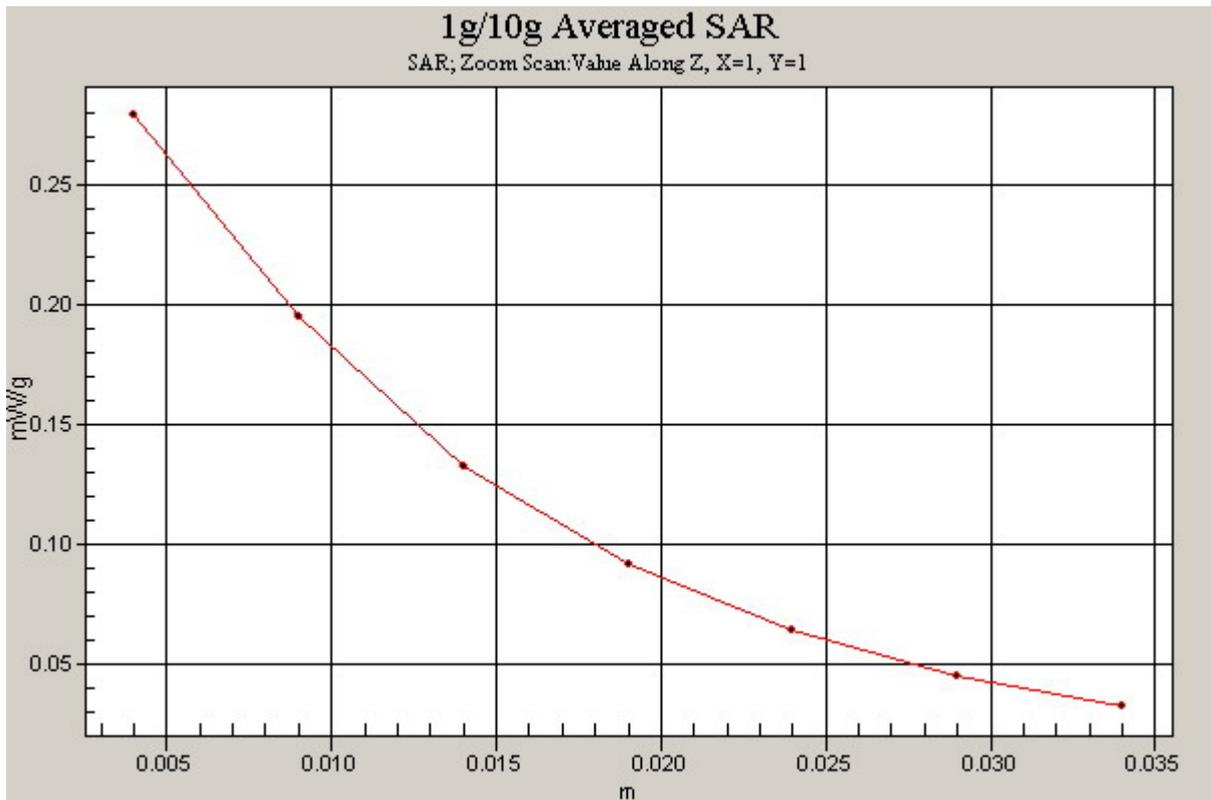


Figure 28 Z-Scan at power reference point [GSM 850 EGPRS with IBM X41 Test Position 1  
CH190 (1 timeslot in uplink)]